

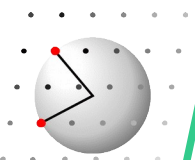


Pair Distribution Function PDF

Reinhard B. Neder

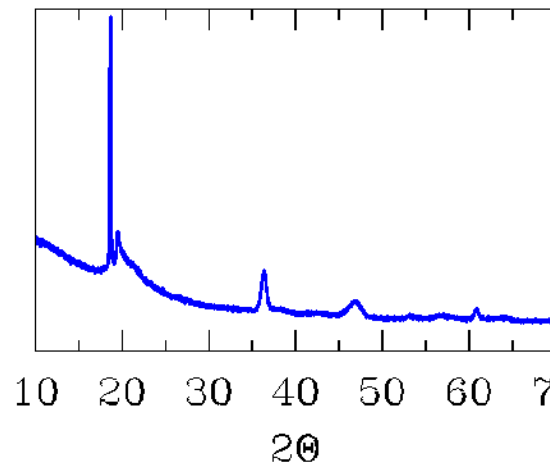
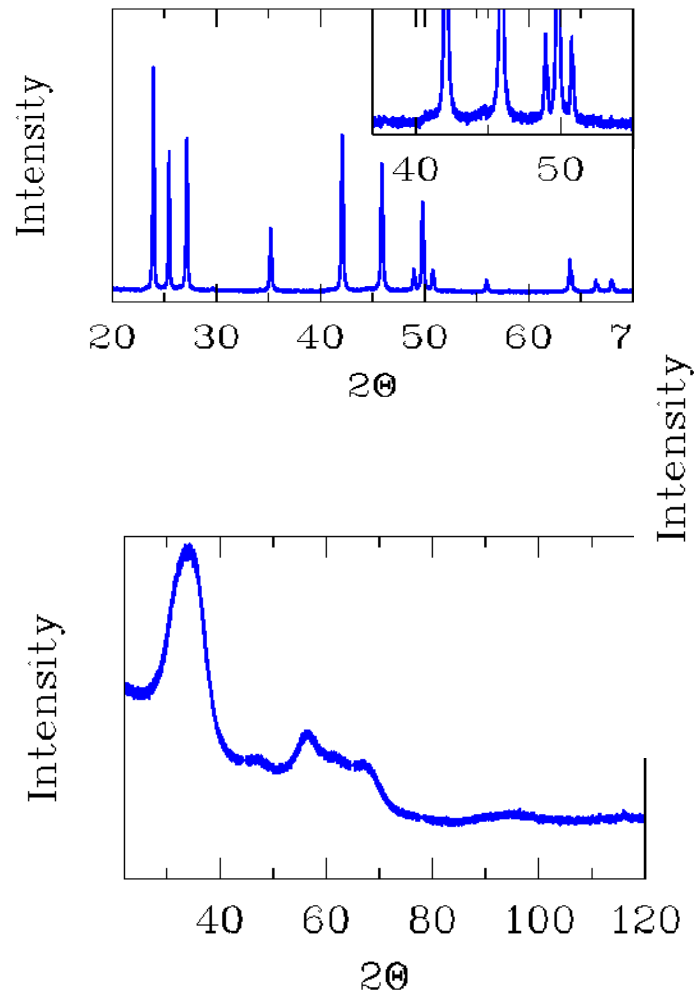
Lehrstuhl für Kristallographie und Strukturphysik
Department Physik
Friedrich-Alexander Universität Erlangen-Nürnberg

reinhard.neder@fau.de



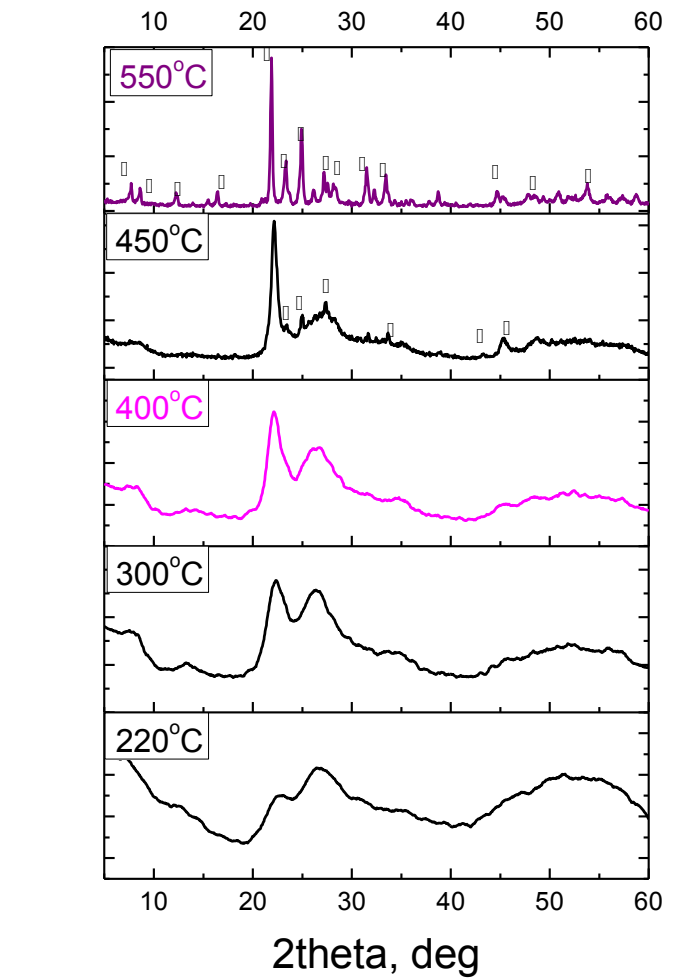
Powder Diffuse Scattering

CdSe crystalline material

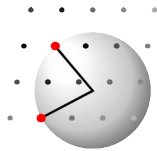


Layered H_2TiO_3

Nano crystalline ZnO



Mo-V-Nb oxides



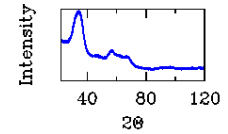
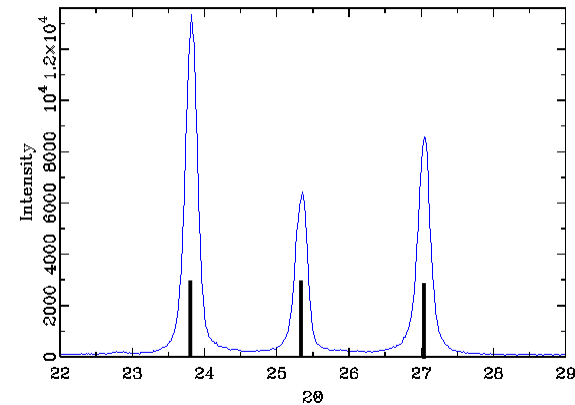
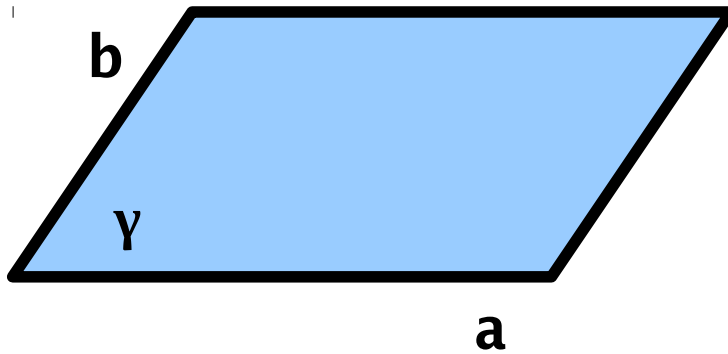
Rietveld refinement

Basic assumption: perfect periodic crystal structure

for all lattice planes:

$$I(2\Theta) = S \sum_{hkl} M(\vec{h}) P(\vec{h}) \left(\left| \sum_{j=1}^N f_j \text{Occ}_j e^{2\pi i \vec{h} \cdot \vec{r}_j} \right|^2 \right) \circ \text{Profile}$$

calculate d-values from unit cell (size and shape)



Scalefactor; **M**ultiplicity; **P**referred orientation

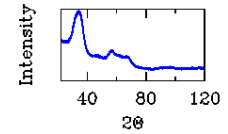


Rietveld refinement

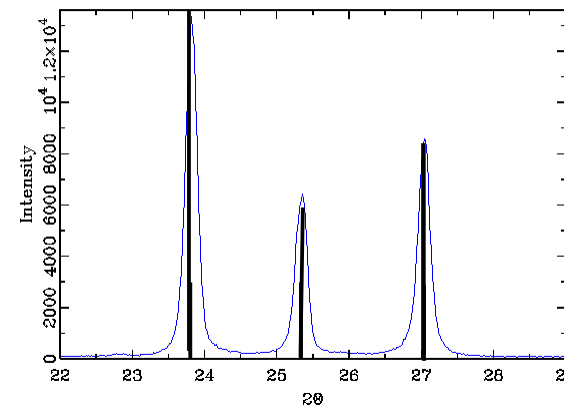
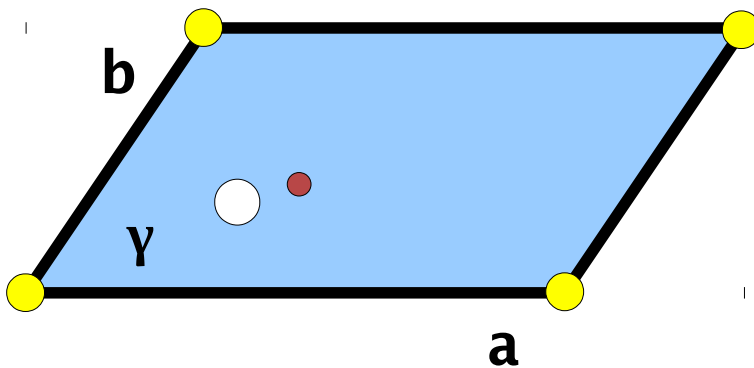
Basic assumption: perfect periodic crystal structure

for all lattice planes:

$$I(2\Theta) = S \sum_{hkl} M(\vec{h}) P(\vec{h}) \left(\sum_{j=1}^N f_j \text{Occ}_j e^{2\pi i \vec{h} \cdot \vec{r}_j} \right) \circ \text{Profile}$$



calculate d-values from unit cell (size and shape)



calculate intensity from **one** unit cell content: Position and type of atoms

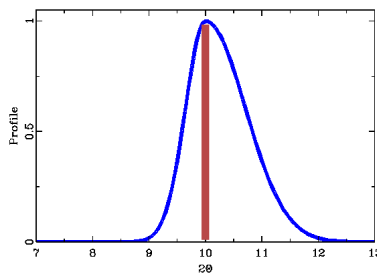
create **reflection shape** via profil function

Instrumental parameters

resolution, wave length distribution, diffractometer

Structural parameters

strain, crystal size



Scalefactor; **M**ultiplicity; **P**referred orientation



Rietveld refinement

Example ZnO Nanoparticle
3,2nm diameter

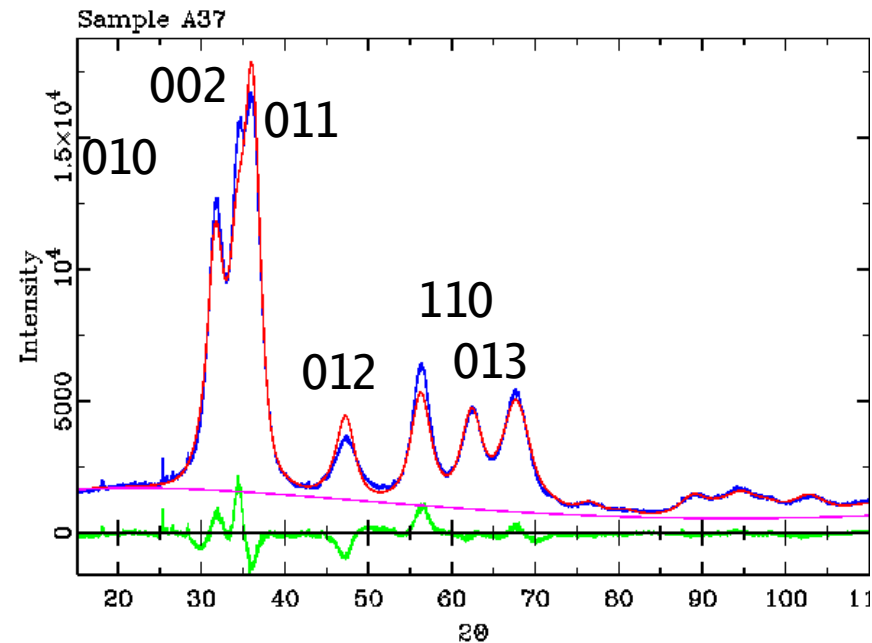
Section of
Powder pattern

Laboratory data

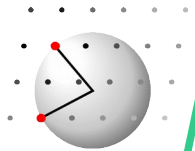
Line: exp. data

Line: calculated profile

Line: Difference: observed - calculated




Reflections $hk0$ are not matched
Reflection 012 broader than calculated
==> disorder
Not part of Rietveld refinement



Debye Equation

calculates intensity from list of atom pairs! **ALL** atoms in the „crystal“

$$\langle |F(\mathbf{h})|^2 \rangle = \sum_j f_j^2 + \sum_i \sum_{j, j \neq i} f_i f_j \sin(2\pi \mathbf{h} \mathbf{r}_{ij}) / (2\pi \mathbf{h} \mathbf{r}_{ij})$$


each individual atom atom pairs

f_i atomic form factor scattered intensity by individual atom,
depends on atom type, radiation

r_{ij} distance from atom i to atom j

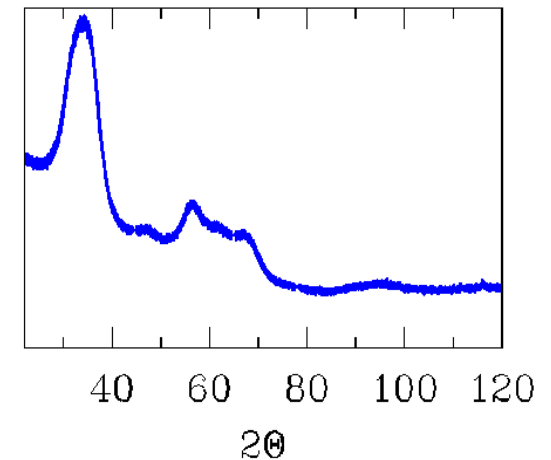
Sum over all atom pairs

→ no restrictions on sample structure

open to finite particle with any shape

defects, like stacking faults etc.

Post processing: convolute with instrumental resolution function



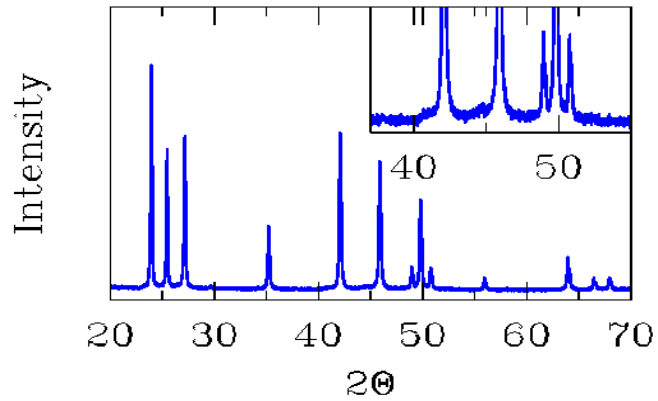
DISCUS program: discus.sourceforge.net; Neder & Proffen (Oxford)

Debussy program: A. Cerevellino

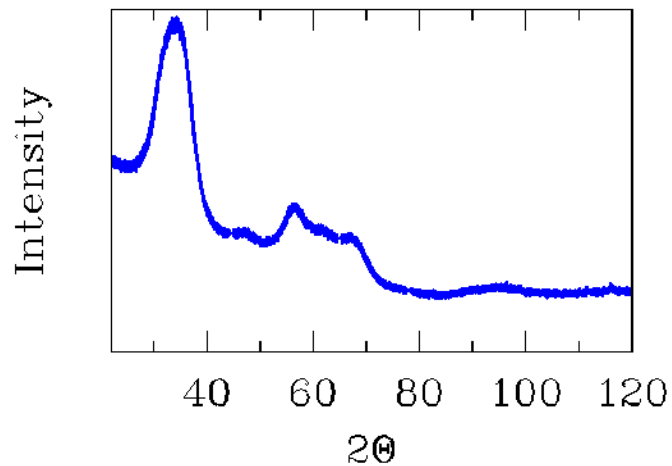


Powder Diffuse Scattering

CdSe crystalline material



Well separated reflections => structure solution



Structure ??

Just a small object with bulk structure ?

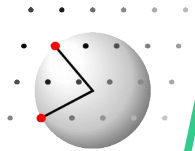
Unique *cluster* structure ?

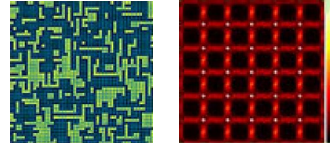
Not enough detail for standard structure determination techniques

Interatomic distances **can** be determined

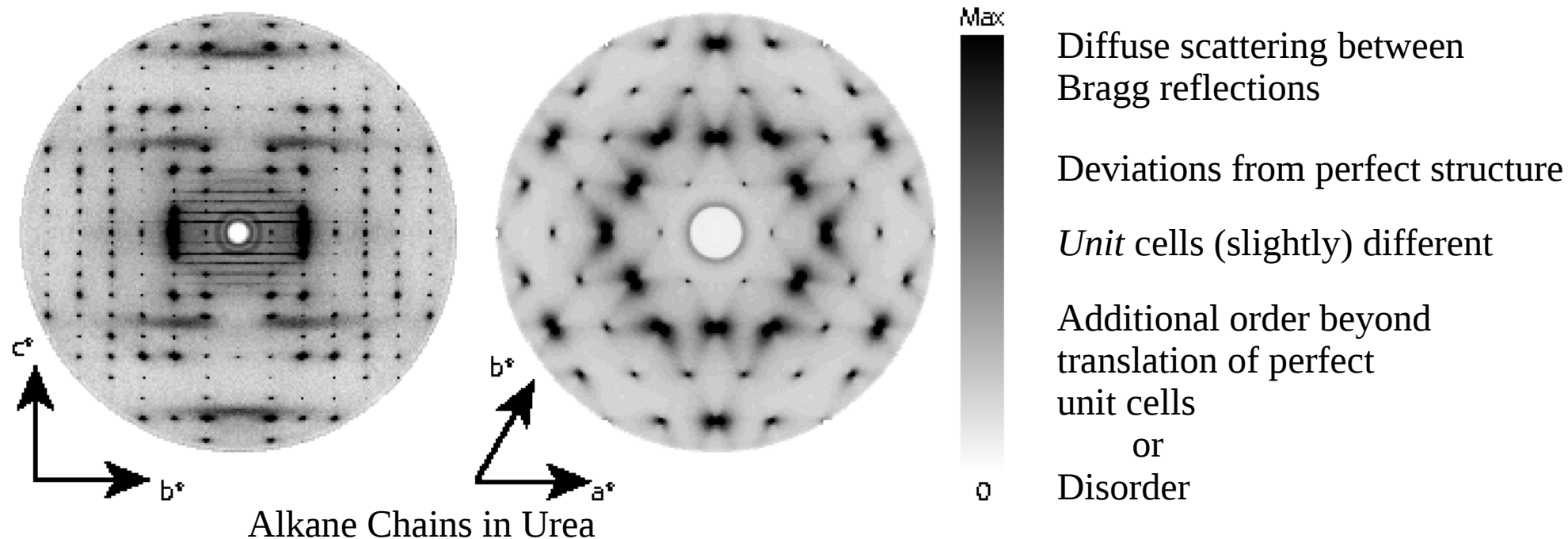
➡ Pair Distribution Function PDF

Nano crystalline ZnO

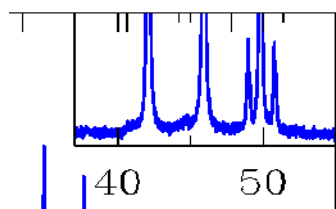




Single Crystal Diffuse Scattering



Effect on powder pattern: weak modulated *background*

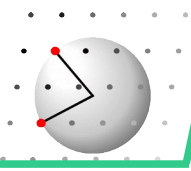


CdSe crystalline material

Not enough detail for single crystal disorder analysis

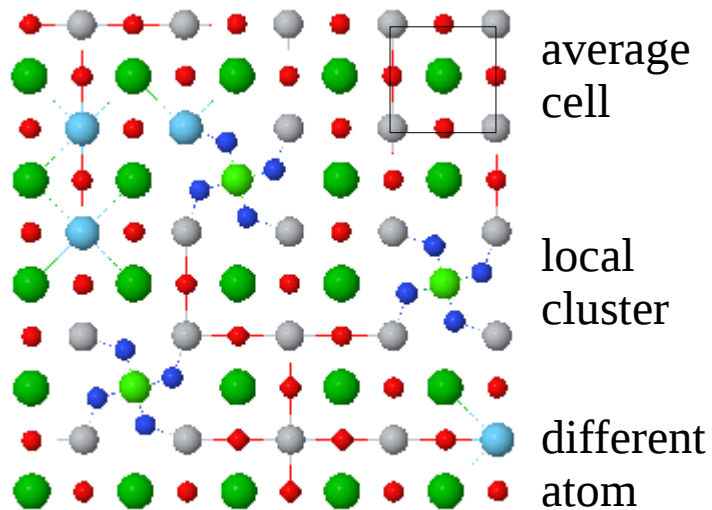
Interatomic distances **can** be determined

→ Pair Distribution Function PDF

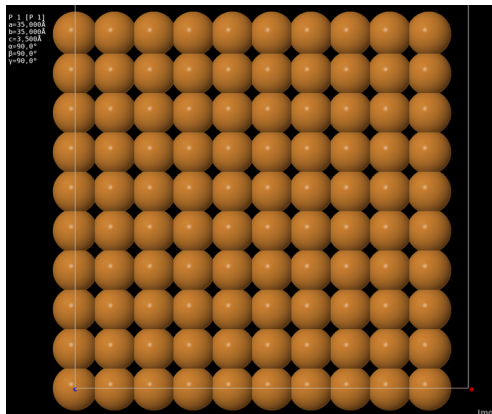


Local structure

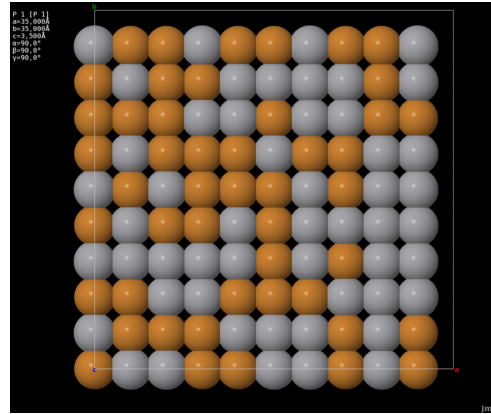
Any deviation from average crystal structure



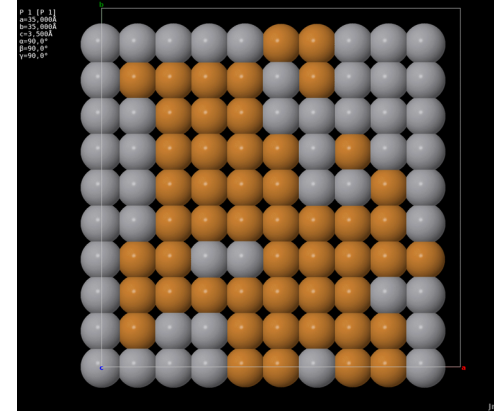
Defects may follow (many) different distribution models



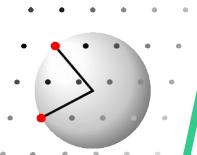
perfect



random distribution



or short range ordered



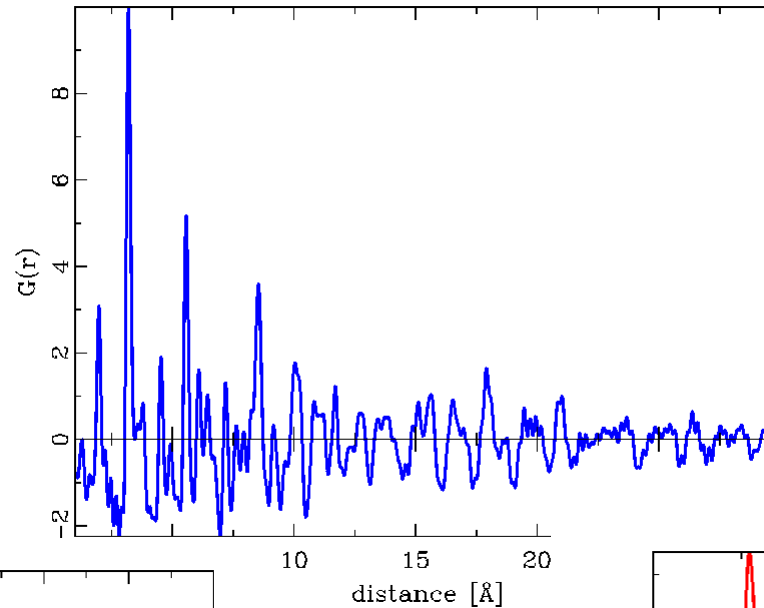
Pair Distribution Function

direct measure of

bond length

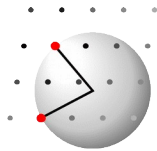
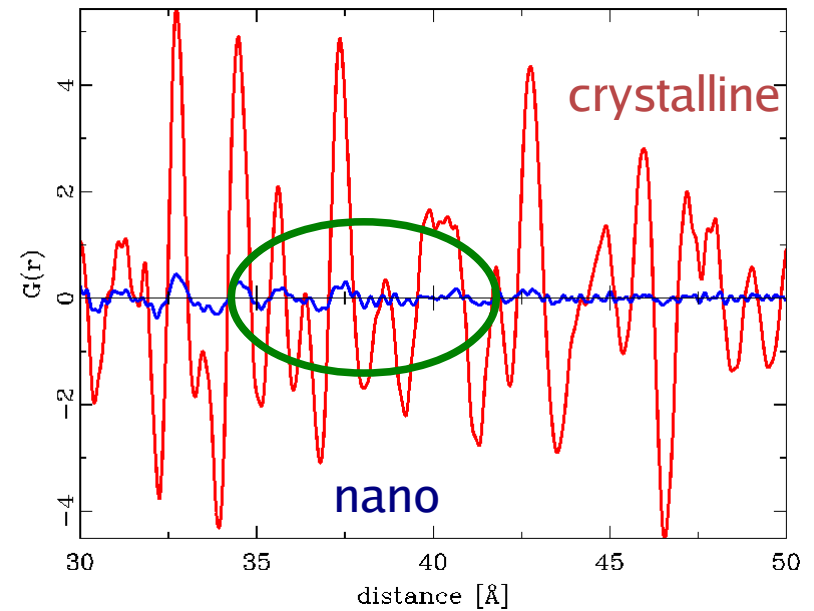
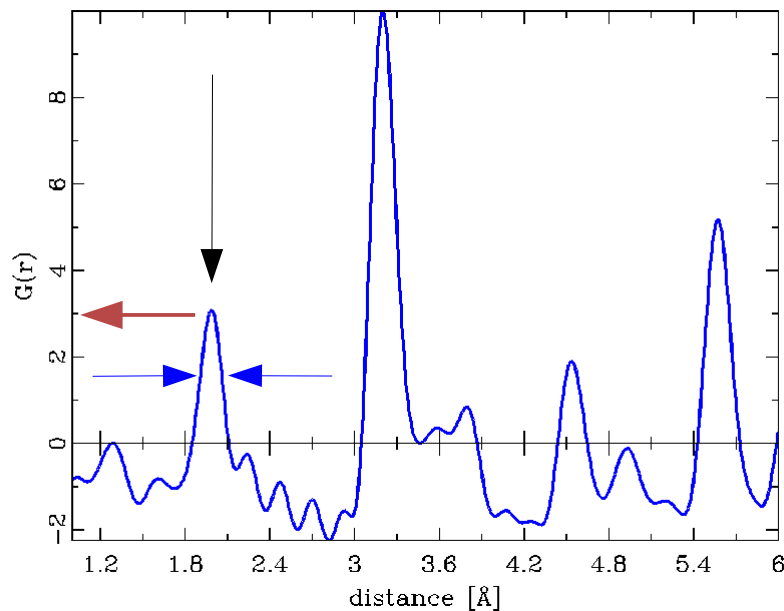
number of neighbors

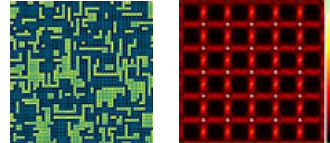
bond length distribution



A pattern in direct space,
essentially a histogram
of interatomic distances,
directly converted from
powder diffraction pattern

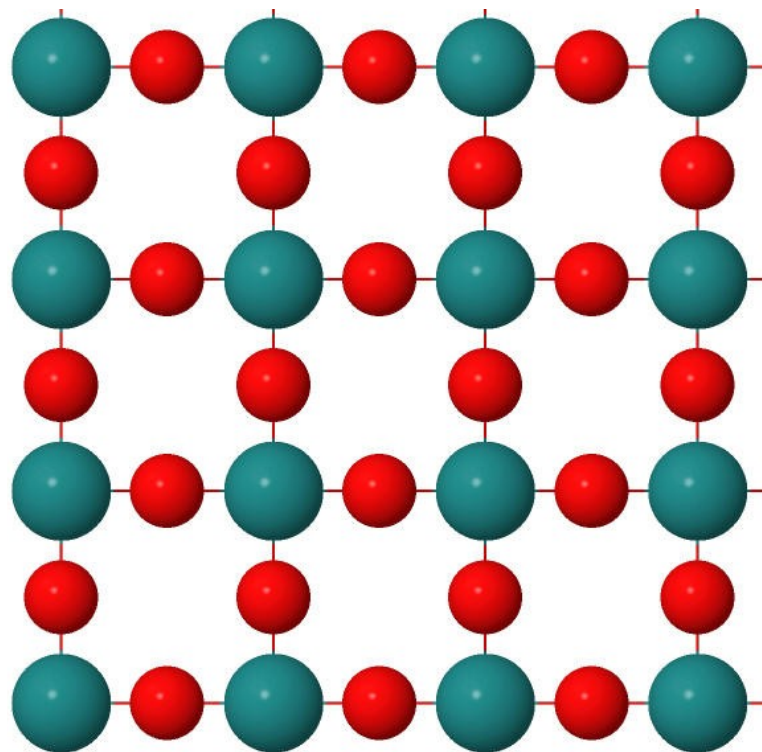
particle diameter
defects



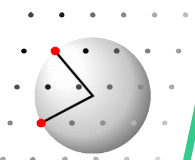


Determination of the Pair Distribution Function

Relationship to crystal structure



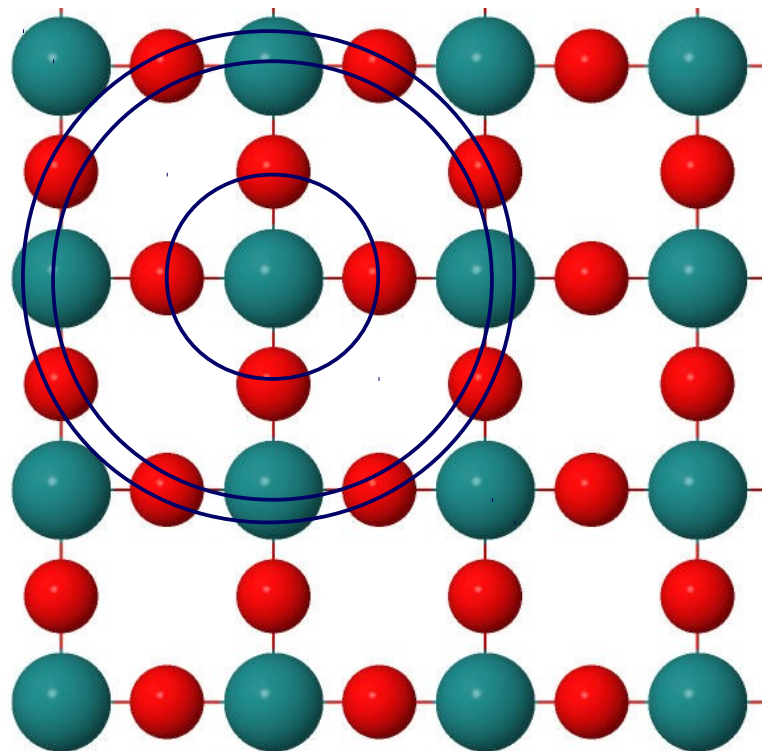
Section of crystal structure





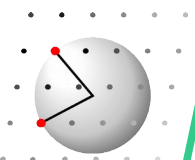
Determination of the Pair Distribution Function

Determination from crystal structure



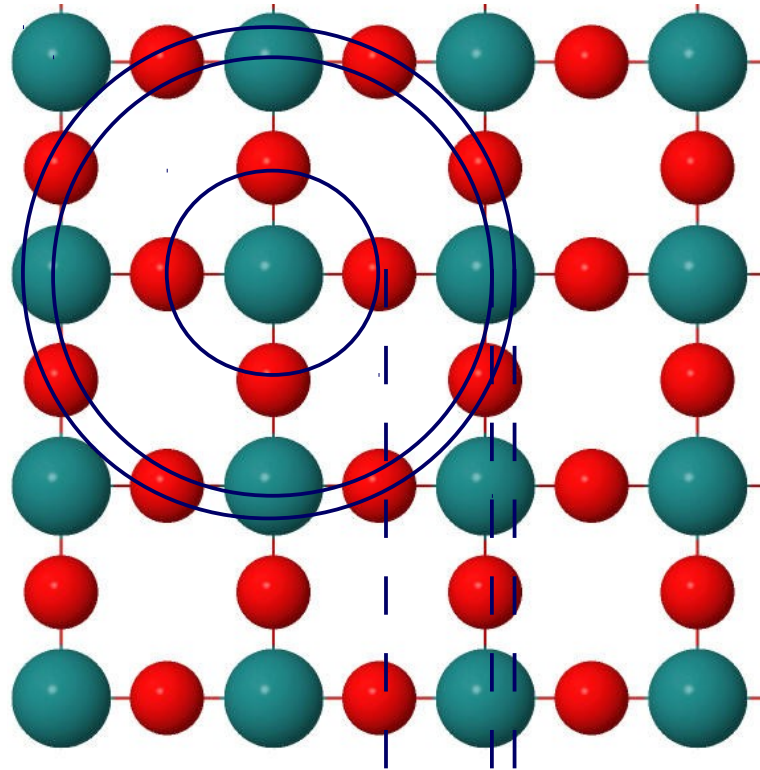
Section of crystal structure

measure all interatomic distances



Determination of the Pair Distribution Function

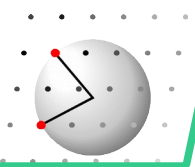
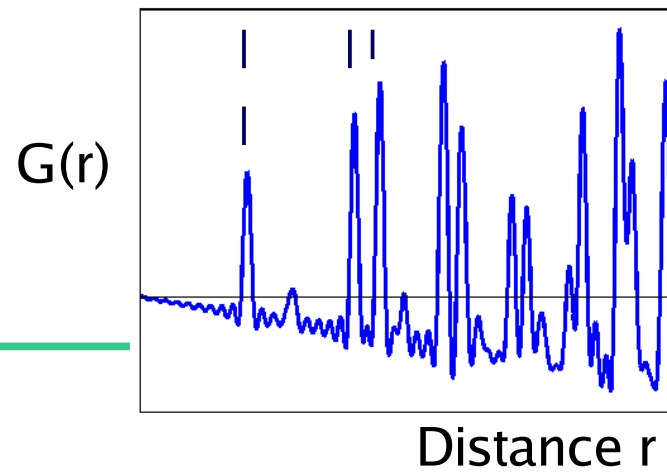
Determination from crystal structure



Section of crystal structure

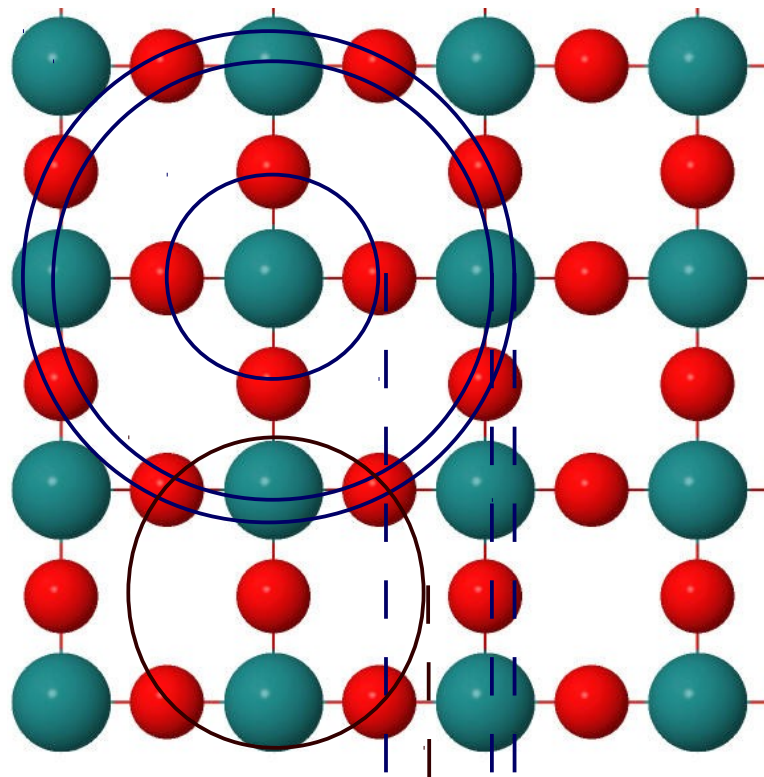
measure all interatomic distances

Project distances into 1-D diagram



Determination of the Pair Distribution Function

Determination from crystal structure



Section of crystal structure

measure all interatomic distances

Project distances into 1-D diagram

$$G(r) = 0$$

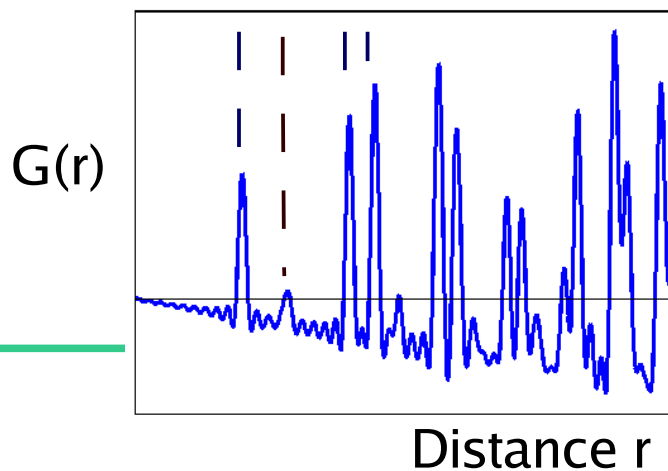
Number of neighbors at r is identical to that in a random structure.

$$G(r) > 0$$

More neighbors than in a random structure.

$$G(r) < 0$$

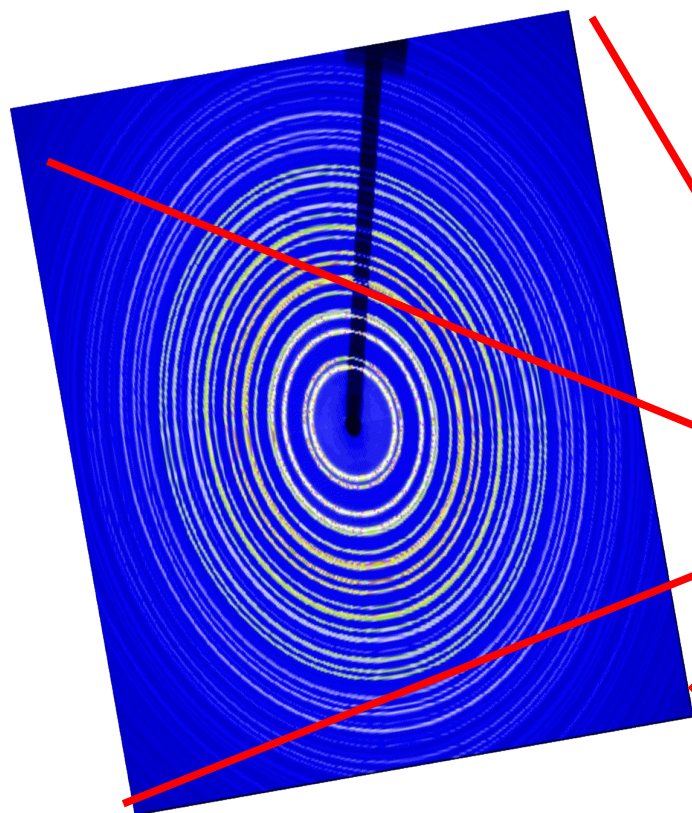
Less neighbors than in a random structure.



PDF definitions: Keen, J. Appl. Cryst (2001) **14**, 172

Experimental Determination of the PDF

Synchrotron Radiation from
hard Xray source $E \sim 60$ to 100keV



Fast area detector

Sample,
Sample environment (T, p, ...)

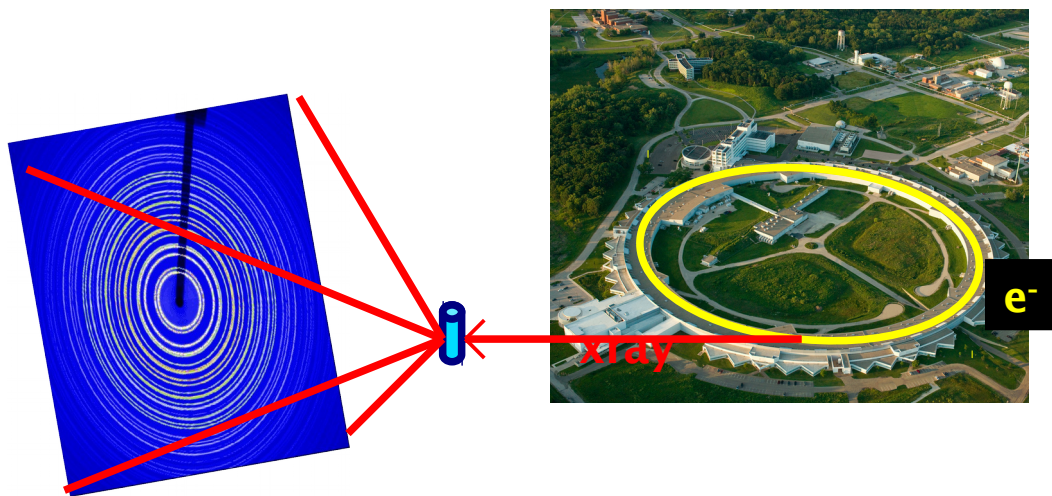
Advanced Photon Source, USA



Beam line 11-IDB

Experimental Determination of the PDF

Synchrotron Radiation from
hard Xray source $E \sim 60$ to 100keV



Dedicated beam lines

11-ID-B APS, Argonne, USA
P. Chupas, K. Chapman

ID15, ESRF, France
S. Kimber

ID31, ESRF, France
T. Buslaps

P21 PETRA III, DESY, Hamburg
DIAMOND, ISIS, England

High resolution beam lines

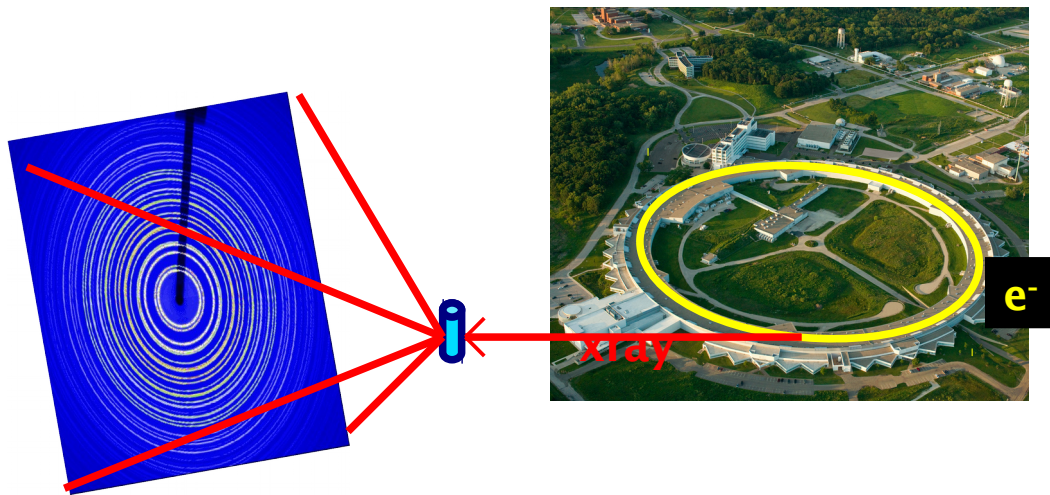
ID22, ESRF, France
A. Fitch

MS X04SA Materials Science Beamline, SLS
A. Cervellino

P03, PETRA III, DESY; Hamburg

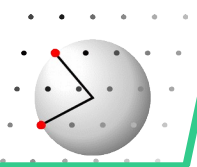
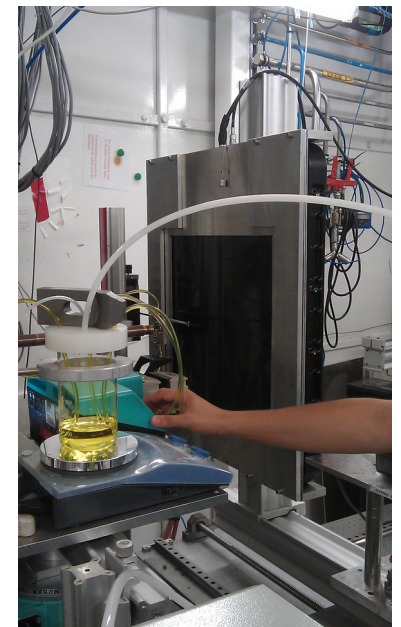
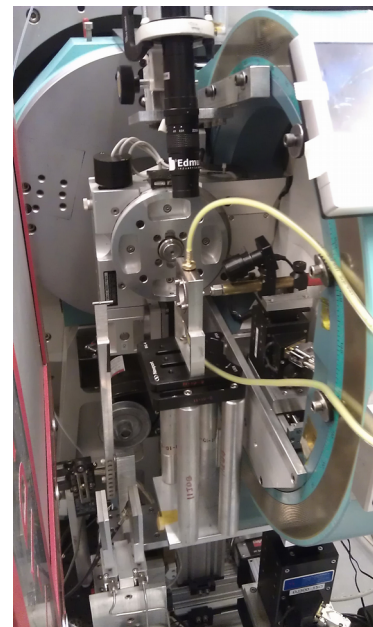
Experimental Determination of the PDF

Synchrotron Radiation from
hard Xray source $E \sim 60$ to 100keV



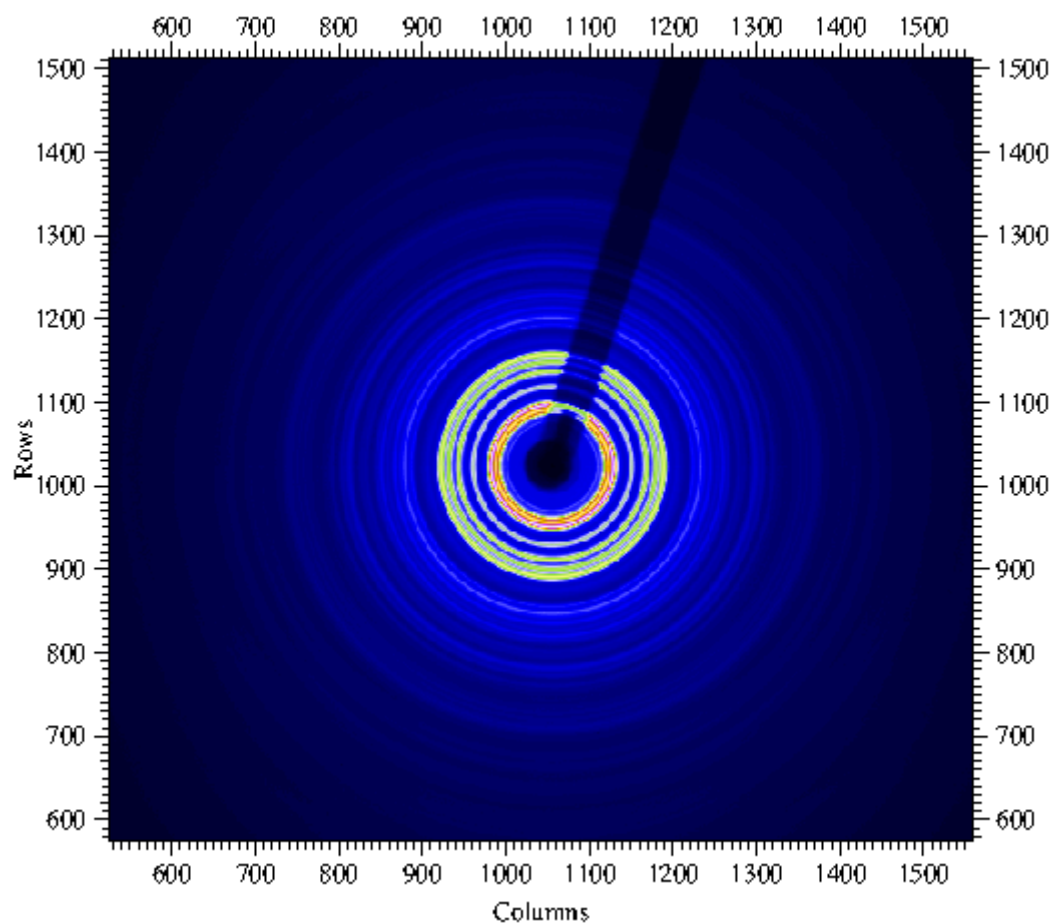
Counting time $1/16\text{ s}$ to 30 sec !!!

Sample,
Sample environment (T, p, ...)



Experimental Determination of the PDF

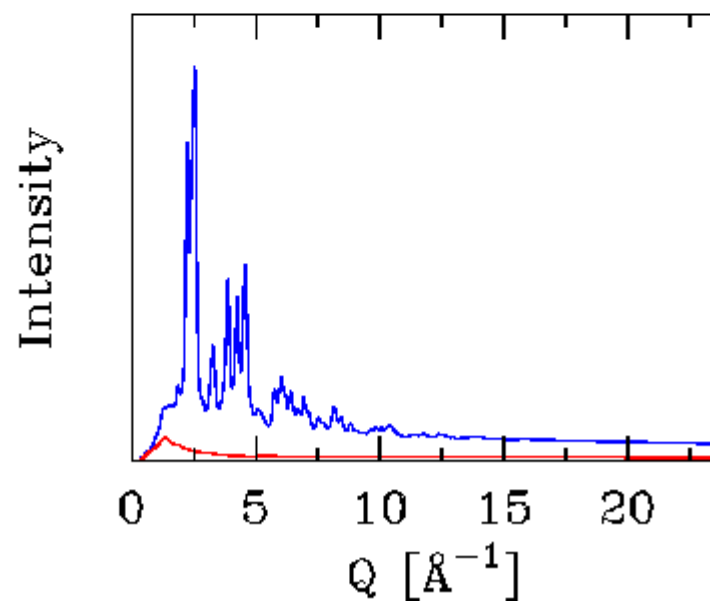
Rapid-aquisition PDF



appr. 1/9 of detector area

Counting time 1/16 s to 30 sec !!!

1st step radial integration FIT2D

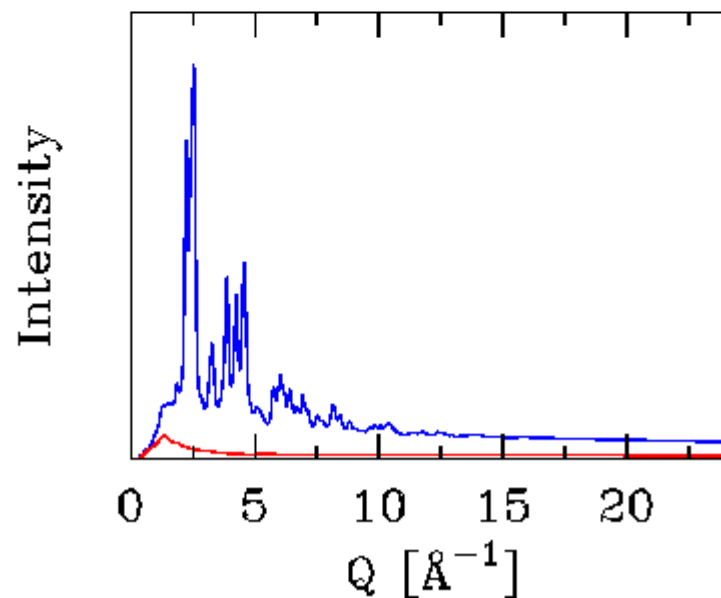


Measure **data** and
background = empty capillary
with good counting statistics
 $\sigma(I) \ll \ll I$!!!!!

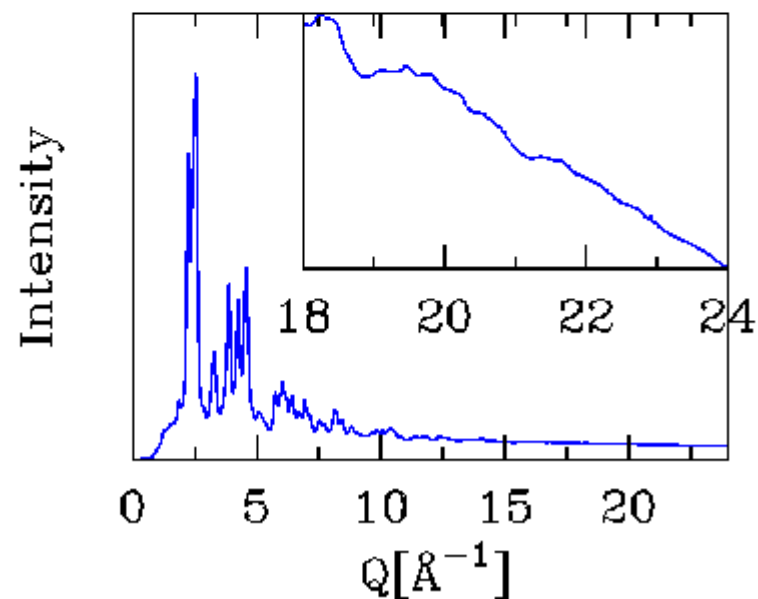
Issues: very accurate detector mask

Experimental Determination of the PDF

Rapid-aquisition PDF



2nd step background subtraction PDFgetx3



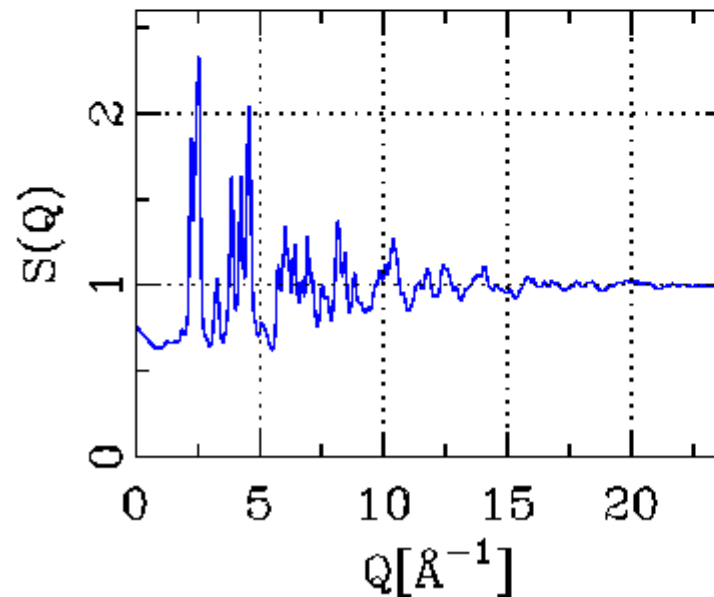
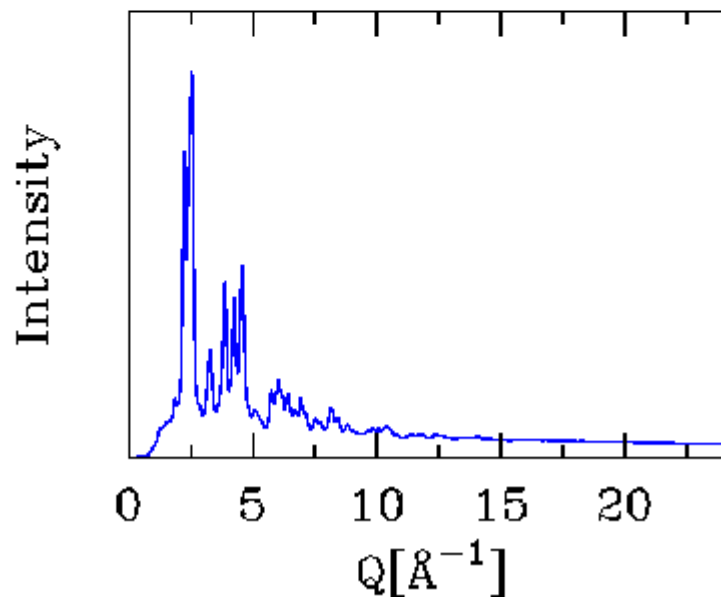
Measure **data** and
background = empty capillary
with good counting statistics

Issues: background scale; $I \geq \text{zero}$!

Experimental Determination of the PDF

Rapid-aquisition PDF

3rd step *corrections* PDFgetx3

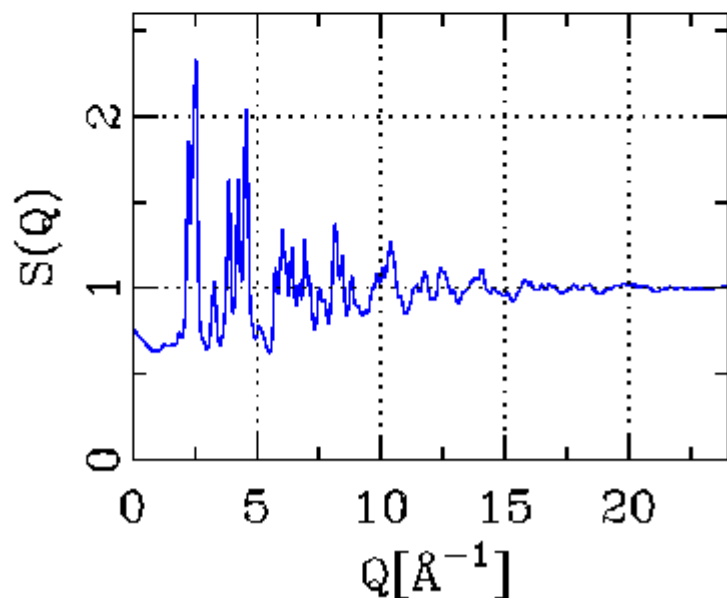


Normalize such that $S(\infty) = 1.0$
(Compton scattering, etc.)
Numerical alchemy

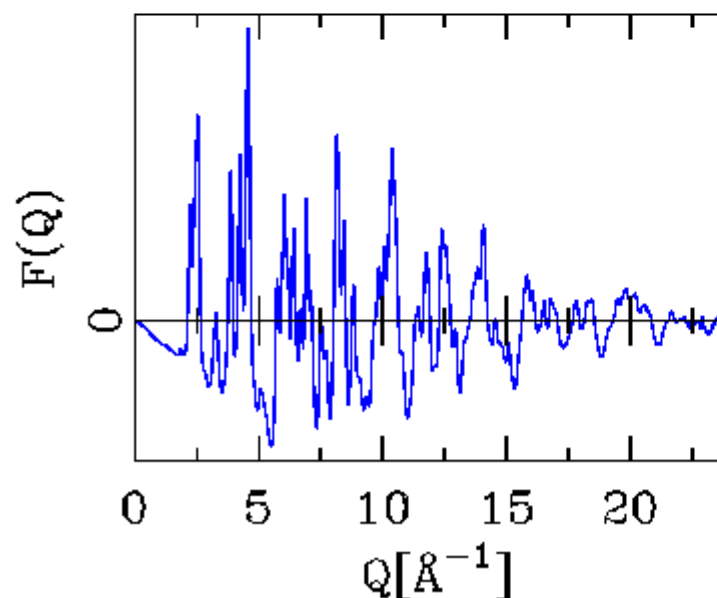
Issues: Is $S(q)$ on average = one
Any odd modulations?
Chemical composition correct?
High absorption ?

Experimental Determination of the PDF

Rapid-aquisition PDF



4th step calc $F(Q)$ PDFgetx3



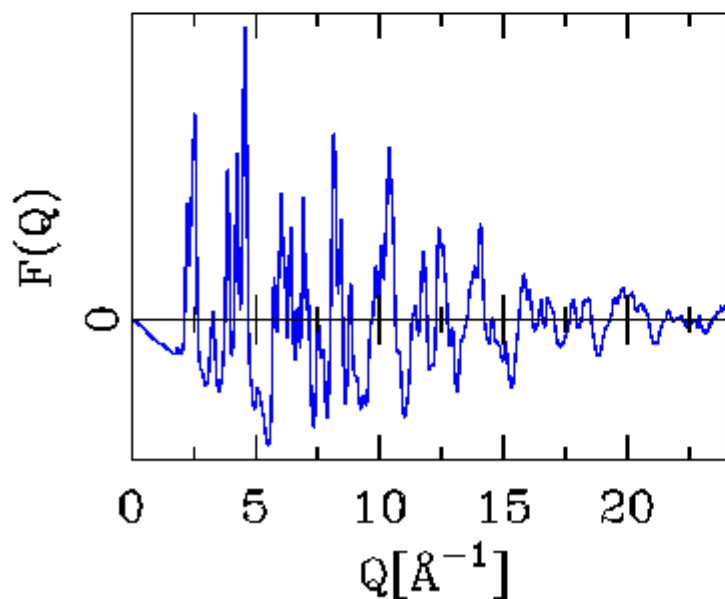
$$F(Q) = Q[S(Q) - 1]$$

Choose Q_{max} such that $F(Q_{\text{max}}) = 1.0$
 Q_{min} usually less critical

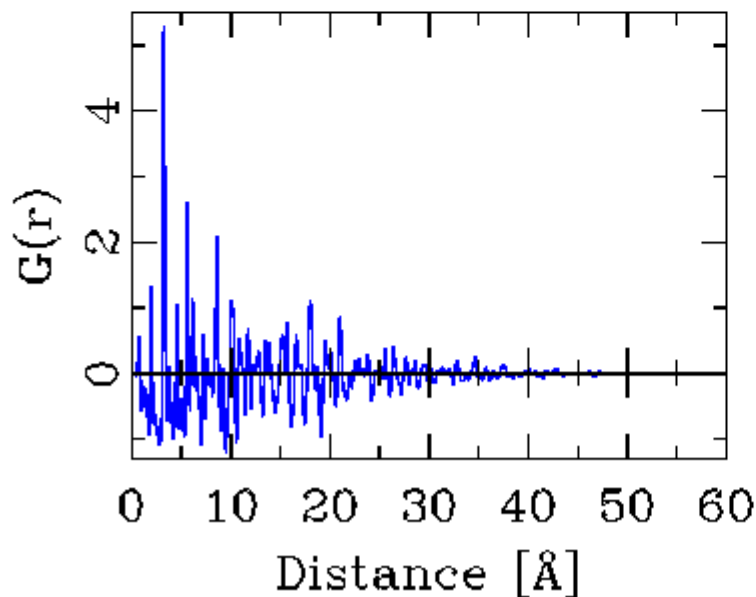
Issues: Is $F(q)$ on average = zero
Any odd modulations?

Experimental Determination of the PDF

Rapid-aquisition PDF



5th step calc $G(r)$ PDFgetx3



$$G(r) = \frac{2}{\pi} \int_0^{\infty} Q[S(Q)-1] \sin(Qr) dQ$$

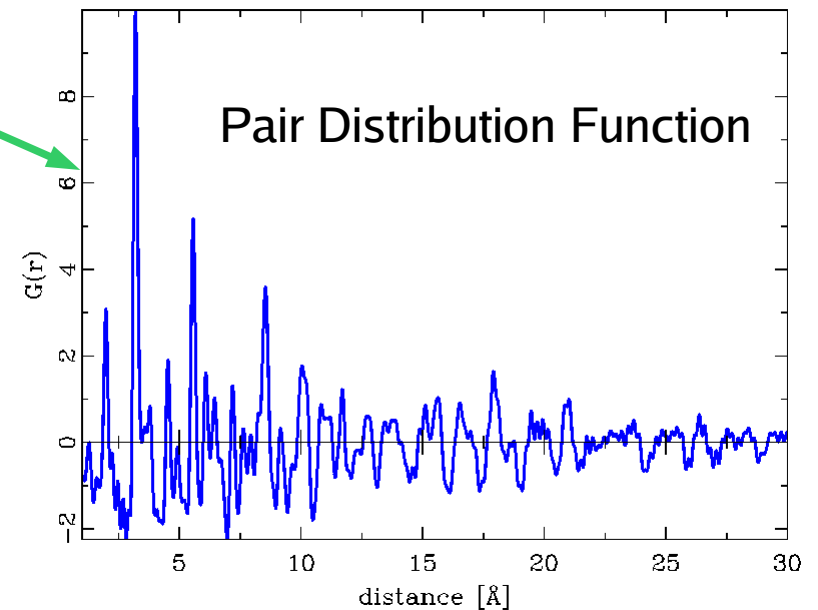
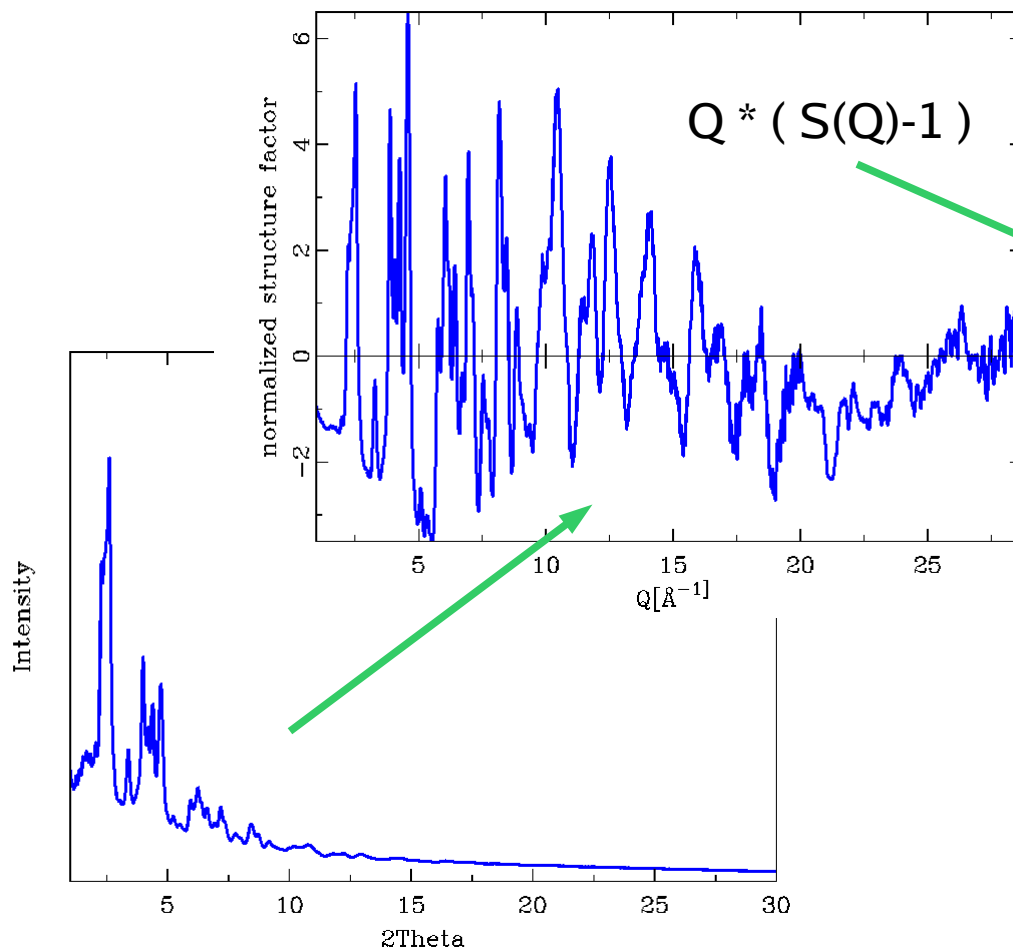
Choose step width $\sim 0.01 \text{ \AA}$
 R_{max} a matter of *choice*

Issues: Is $G(r)$ on average = zero
Any odd modulations?
Odd spikes at low R region?
Region below $r=r_{\text{poly}}$ is meaningless

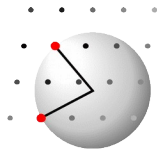
Experimental Determination of the PDF

Q_{\max} determines width of PDF peaks

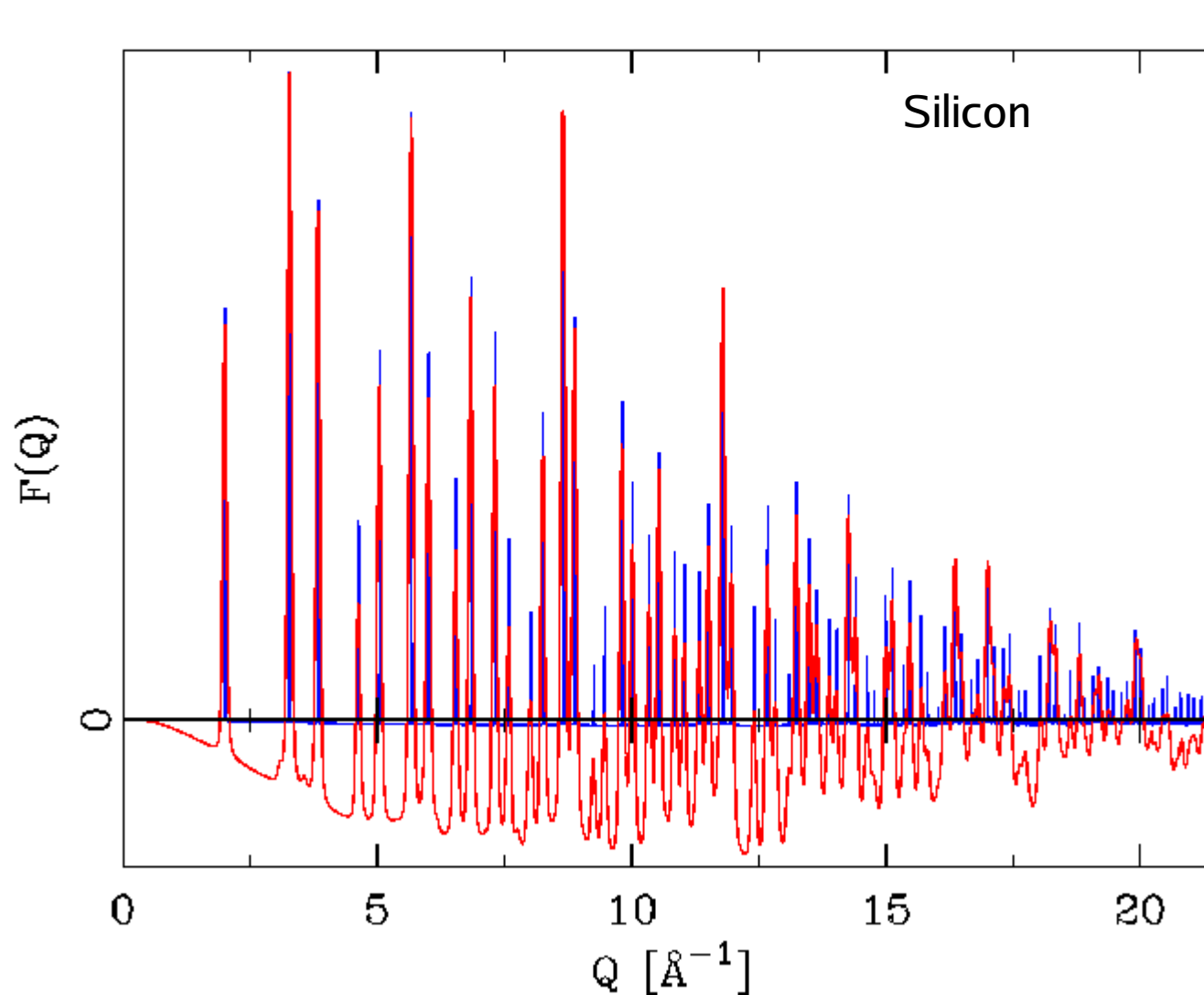
Resolution determines peak height at large r



$$G(r) = \frac{2}{\pi} \int_0^{\infty} Q[S(Q)-1] \sin(Qr) dQ$$



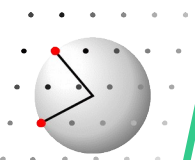
Experimental Determination of the PDF, Instrumental resolution



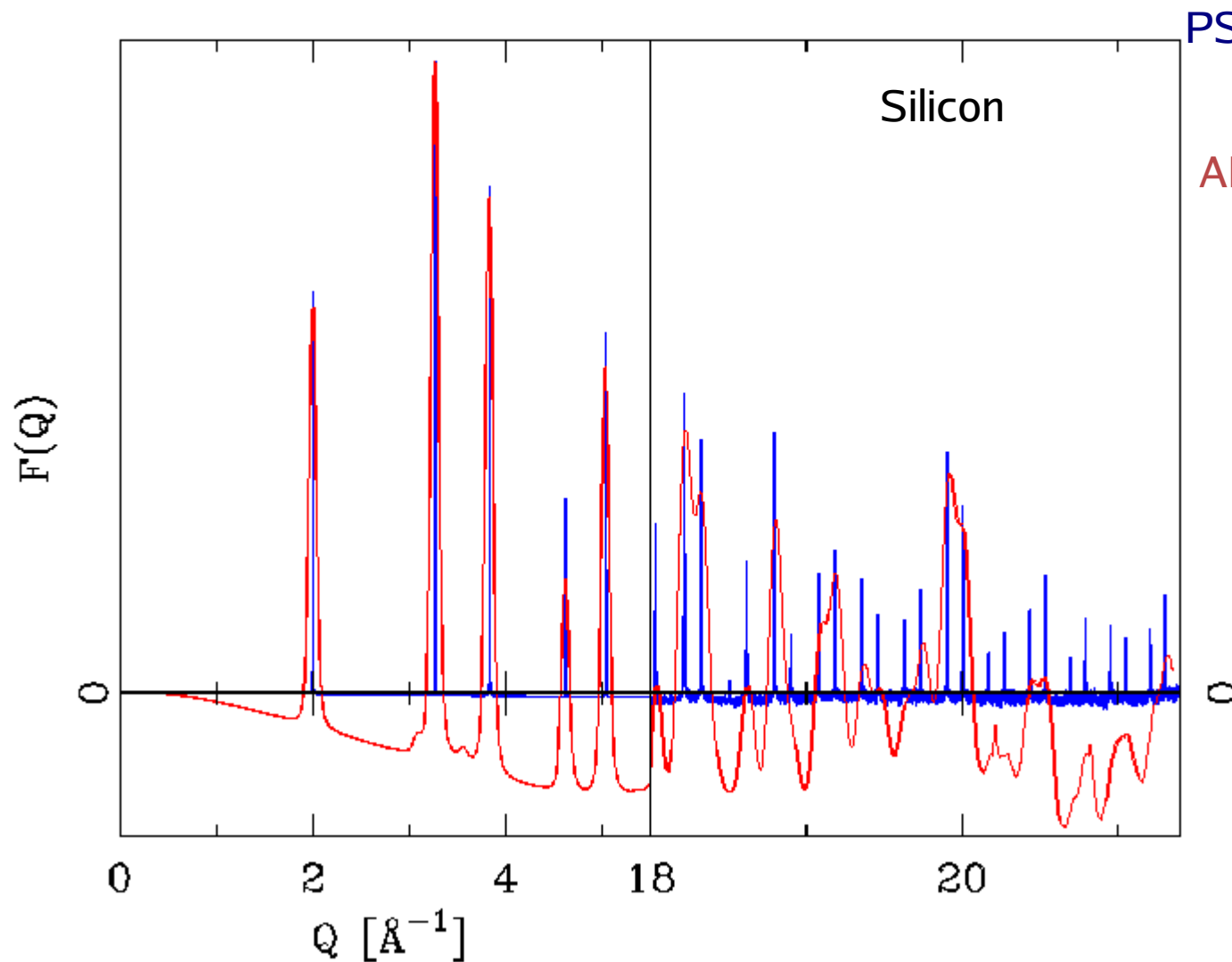
PSI high resolution data
~ 30 min

APS low resolution data
~ 1 min

Reflections well resolved
at PSI up to
and beyond 21.4 \AA^{-1}



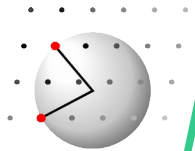
Experimental Determination of the PDF



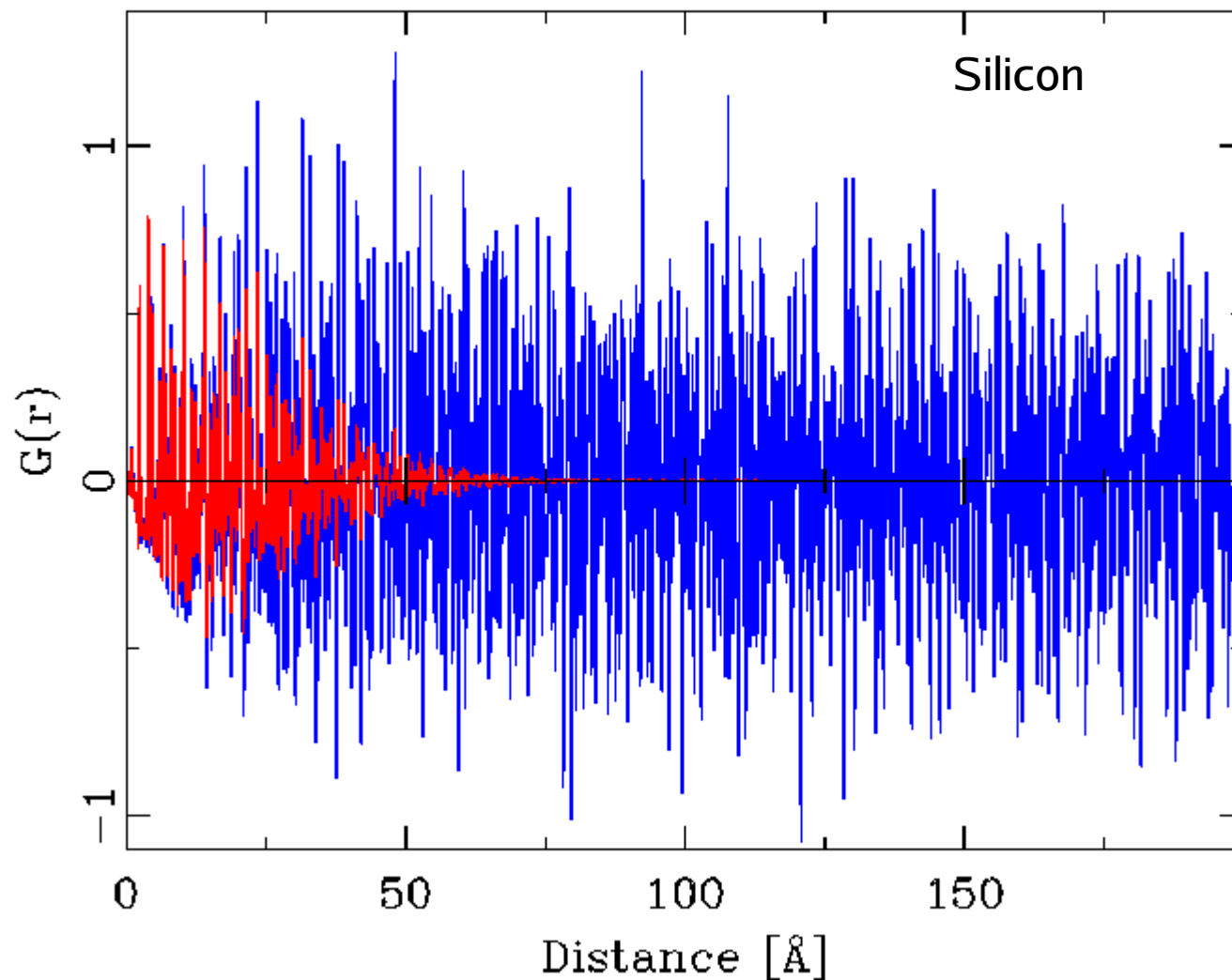
PSI high resolution data
~ 30 min

APS low resolution data
~ 1 min

Reflections well resolved
at PSI up to
and beyond 21.4 \AA^{-1}



Experimental Determination of the PDF



PSI high resolution data
~ 30 min

APS low resolution data
~ 1 min

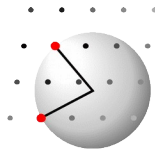
Reflections well resolved
at PSI up to
and beyond 21.4 \AA^{-1}

$G(r)$ @ PSI extends well
beyond 200 \AA !

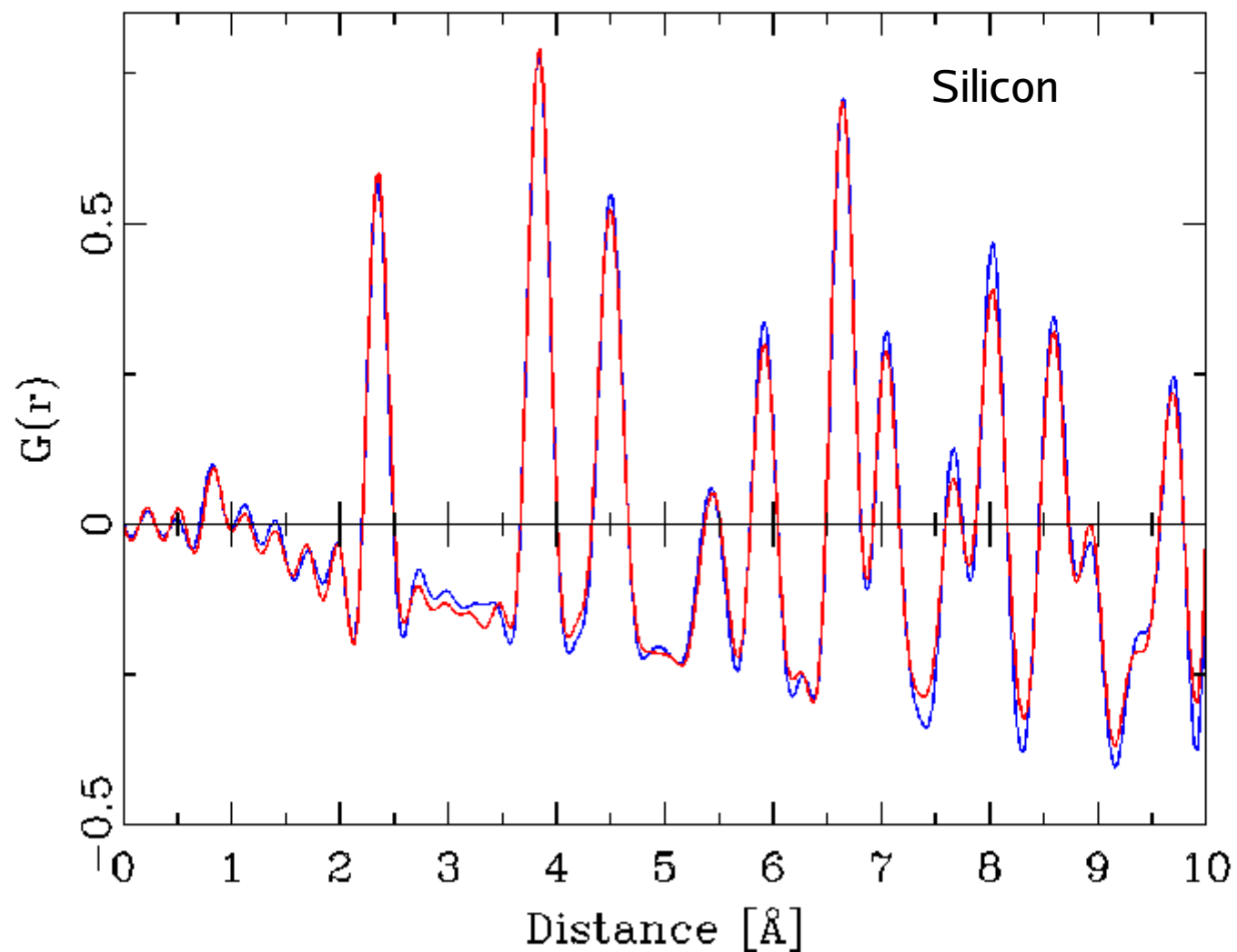
$G(r)$ @ APS almost ZERO
beyond 70 \AA !

PDF peak height influences determination of nanoparticle diameter

High resolution NOT needed for small ($< 5 \text{ nm}$) objects; only good if sample has narrow Bragg



Experimental Determination of the PDF



PSI high resolution data
~ 30 min

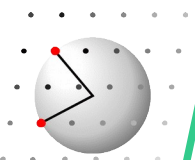
APS low resolution data
~ 1 min

Reflections well resolved
at PSI up to
and beyond 21.4 \AA^{-1}

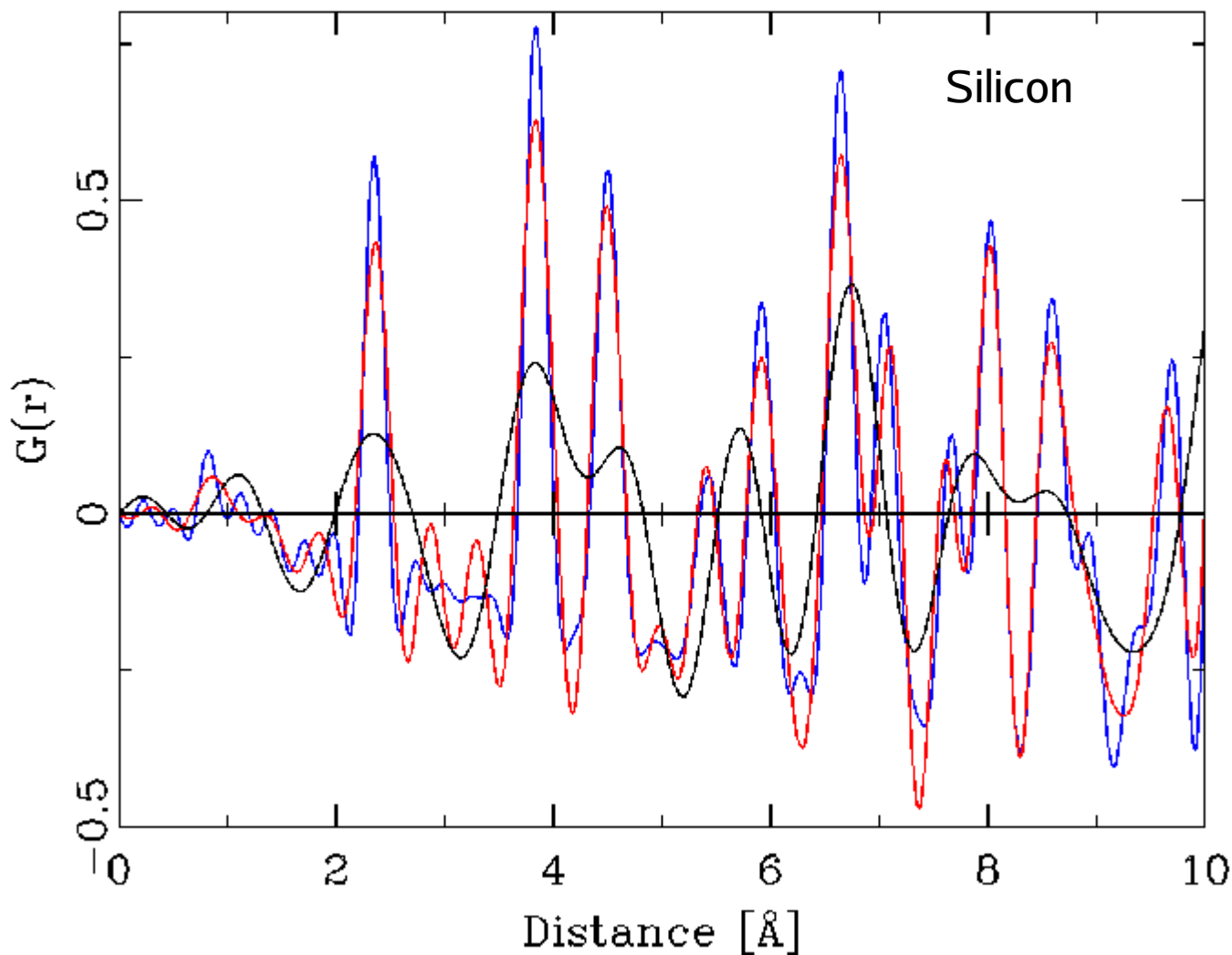
$G(r)$ @ PSI extends well
beyond 200 \AA !

$G(r)$ @ APS almost ZERO
beyond 70 \AA !

Width of PDF maxima
is identical
(at least for low r -region)



Experimental Determination of the PDF, Effect of Q_{\max}



PSI high resolution data
Silicon

$Q_{\max} = 21. \text{ \AA}^{-1}$

Synchrotron

$Q_{\max} = 15. \text{ \AA}^{-1}$

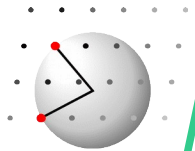
Mo-K α

$Q_{\max} = 7. \text{ \AA}^{-1}$

Cu-K α

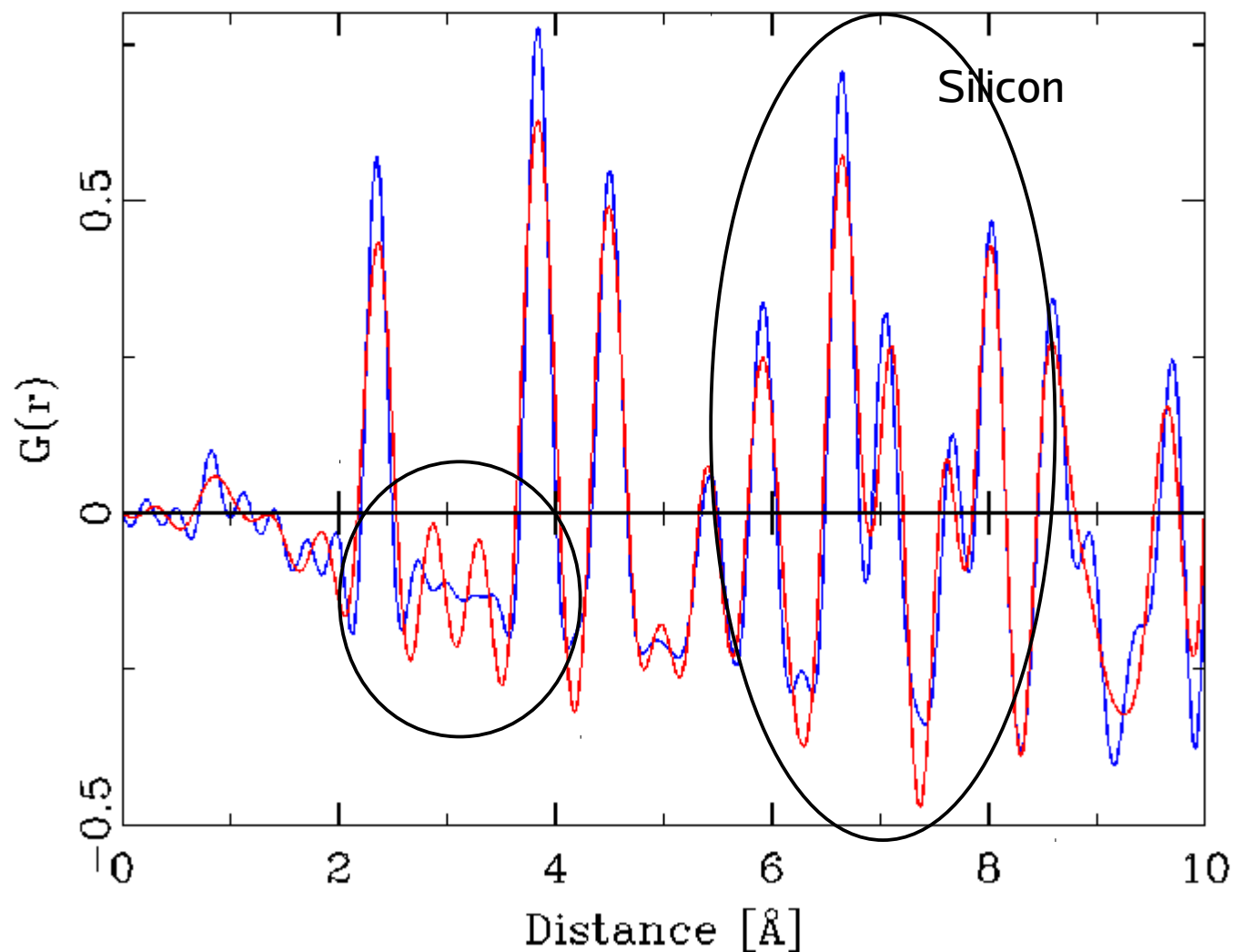
Width of PDF maxima
decreases with increasing
 Q_{\max}

Reasonable for $Q_{\max} > 20 \text{ \AA}^{-1}$





Experimental Determination of the PDF, Effect of Q_{\max}



PSI high resolution data
Silicon

$Q_{\max} = 21. \text{Å}^{-1}$
Synchrotron

$Q_{\max} = 15. \text{Å}^{-1}$
Mo-K α

*Apparent shift of
smaller PDF maxima !?!*

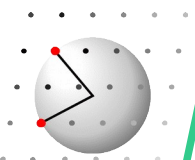
decreases with increasing
 Q_{\max}

Be careful with direct
interpretation of peak positions!

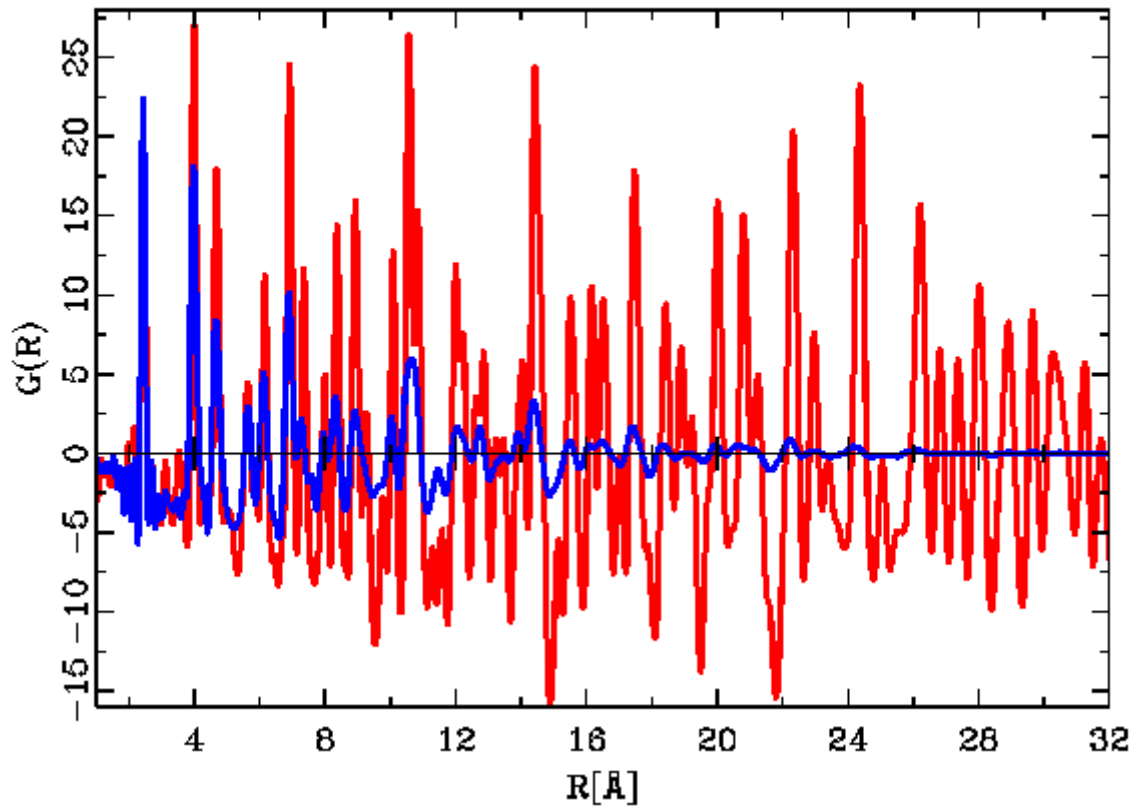
Local disorder in Si !?!

Anything that changes with
 Q_{\max} is not real

Always calculate PDF for several different values of Q_{\max}



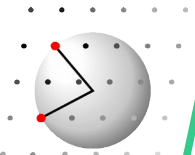
Interpretation of the PDF; ZnSe nanoparticles



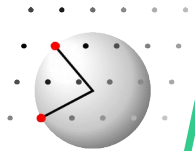
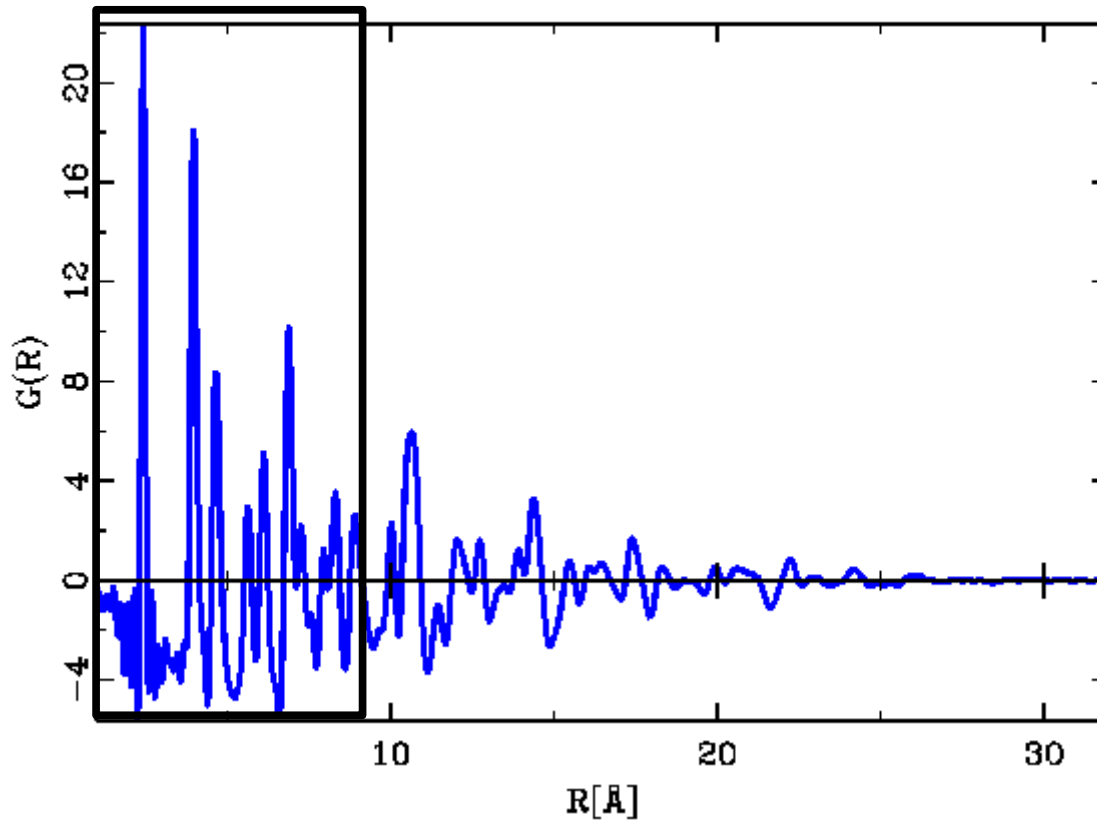
crystalline ZnSe

nanocrystalline ZnSe

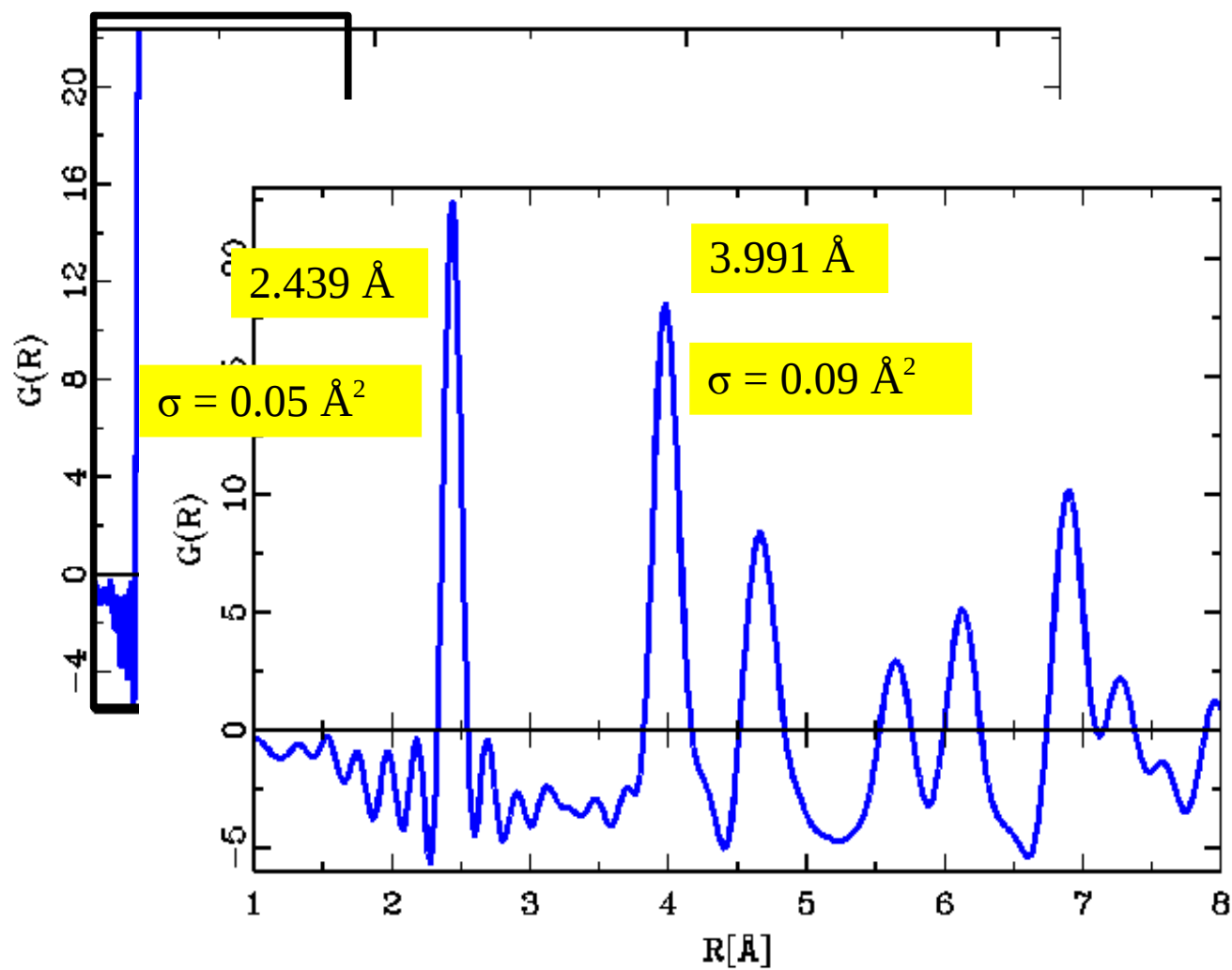
data collected under identical conditions



ZnSe nanoparticles

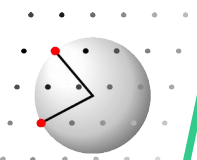
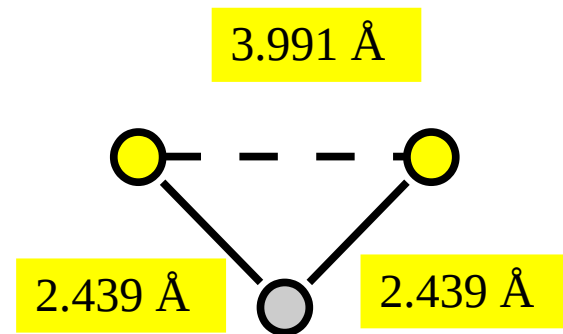


ZnSe nanoparticles

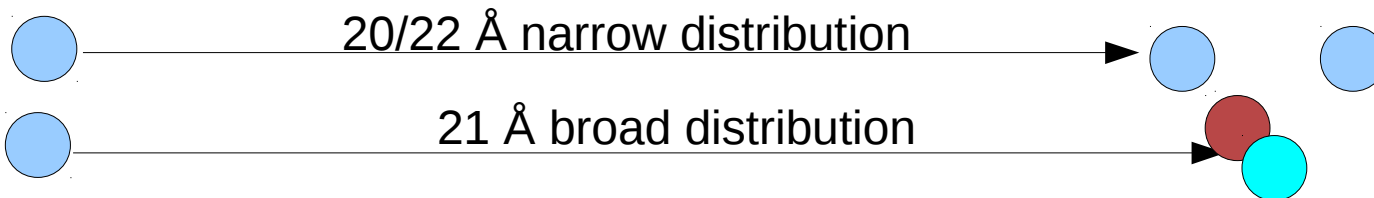
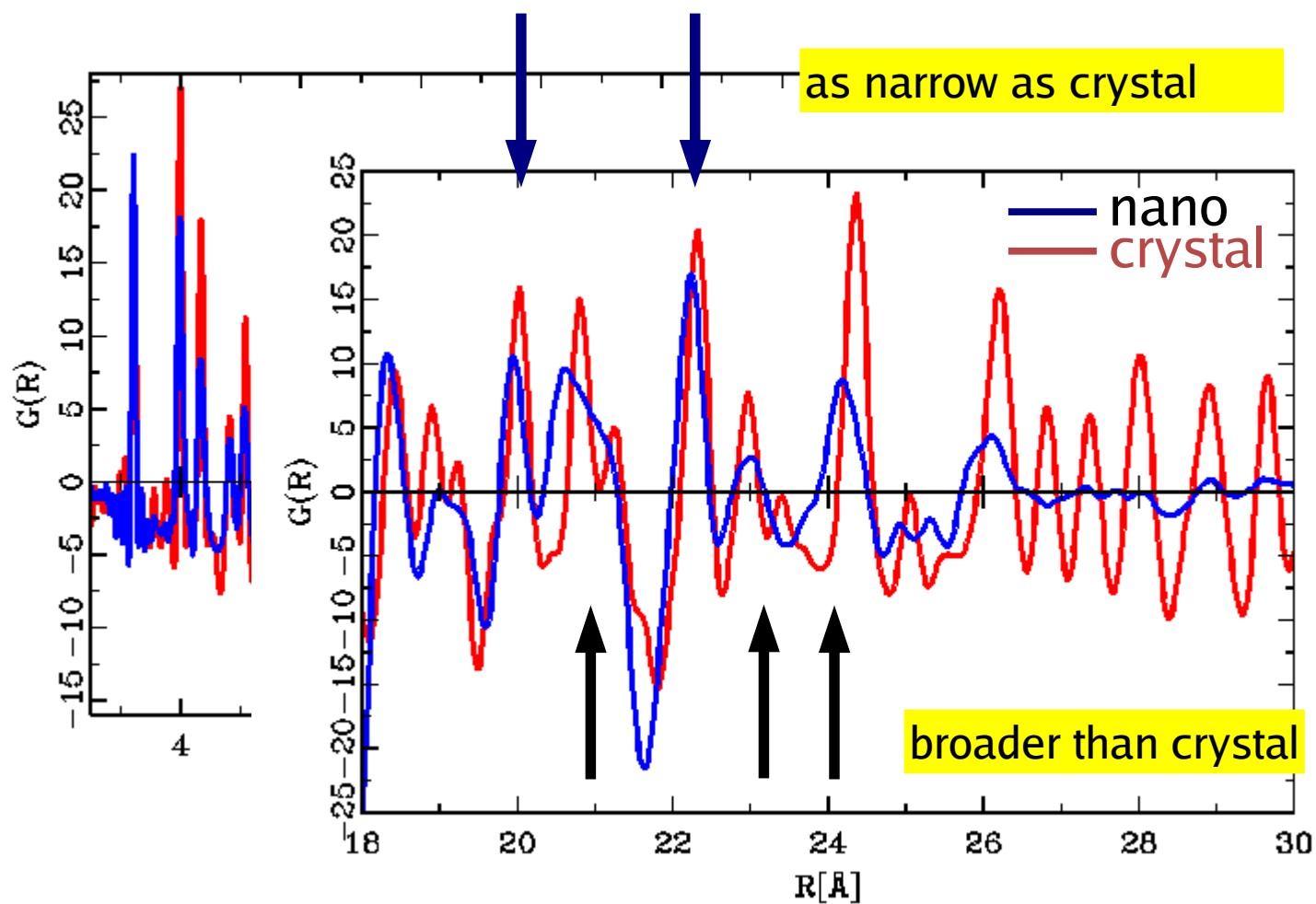


tetrahedral structure

bond angle 109.8°

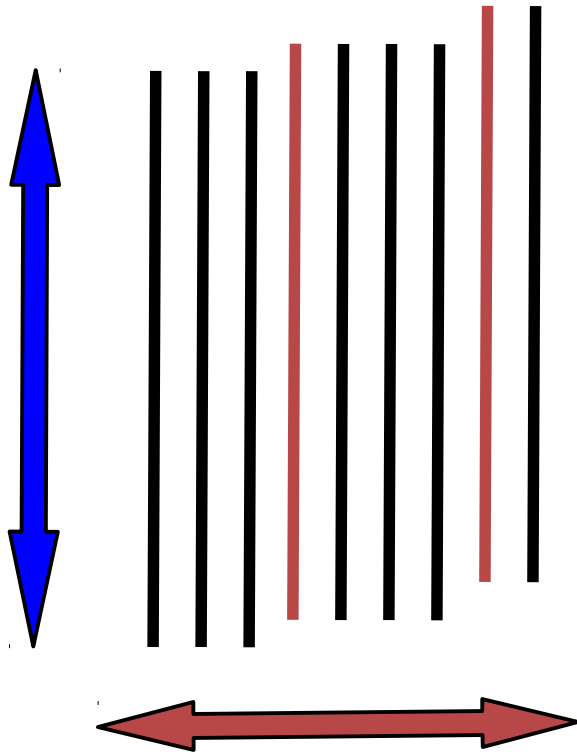


ZnSe nanoparticle: Indication of stacking faults



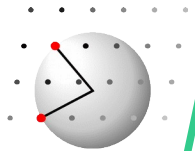
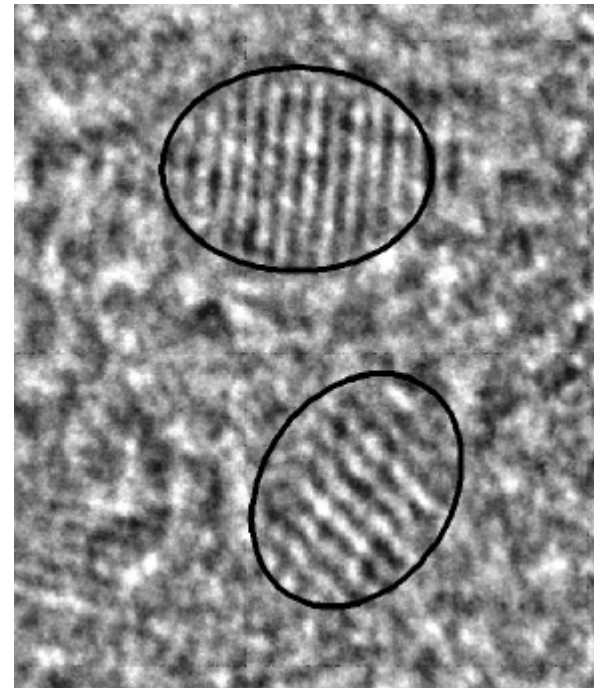
ZnSe nanoparticle: indication of stacking faults

structural coherence



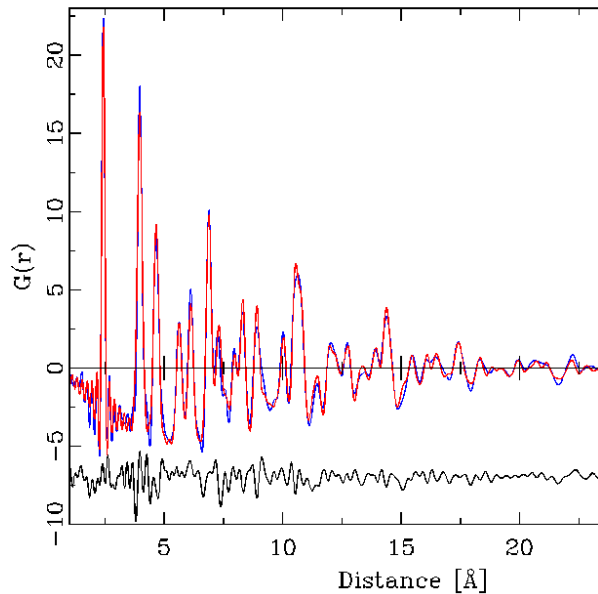
loss of coherence due
to stacking faults

~8 to 10 monolayers
= 4 to 5 unit cells along c
= 24 to 30 Å

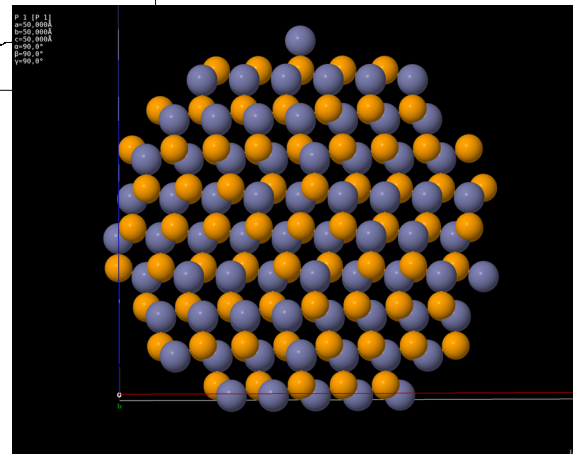
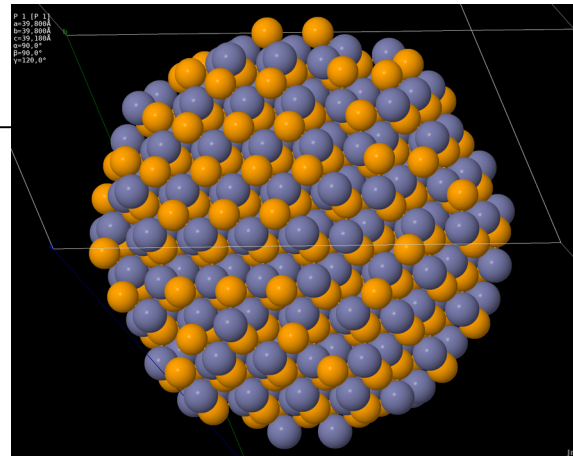


Bottom-Up Simulation and Refinement

Calculate **all** atom positions



Presence of **defects**



3 nm sphere **600 atoms**
 1800 coordinates !
 600 ADP's !

Parameterize description

coordinates in asymmetric unit
symmetry
diameter

2 lattice parameters
1 coordinate
1 ADP
1 radius

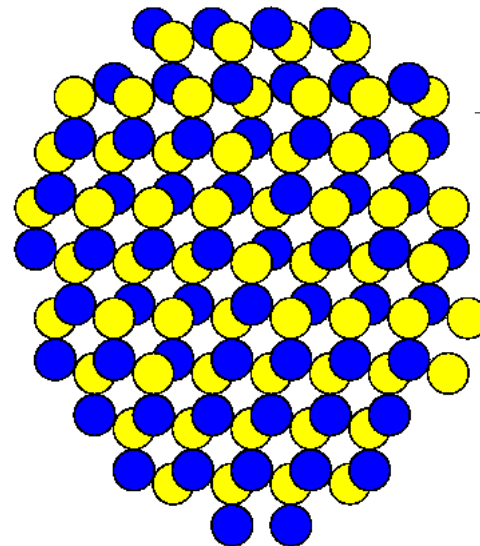
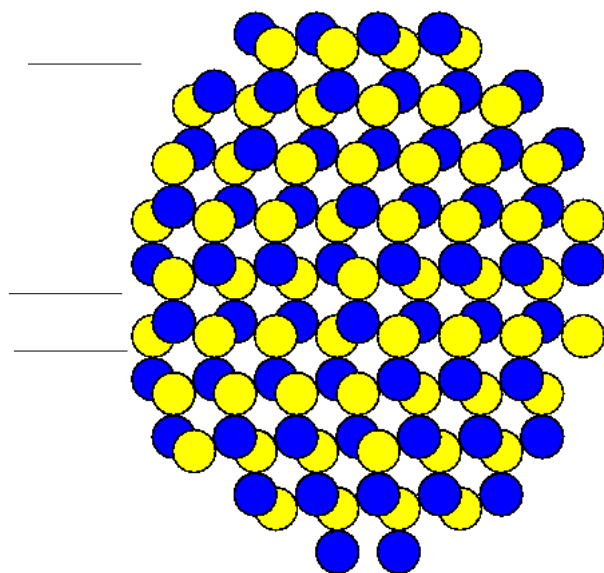
Parameterize description

probability of faults
strain field
chemical short range order
etc....

1 probability
limited only by imagination

BUT

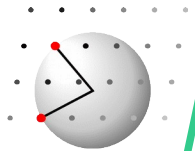
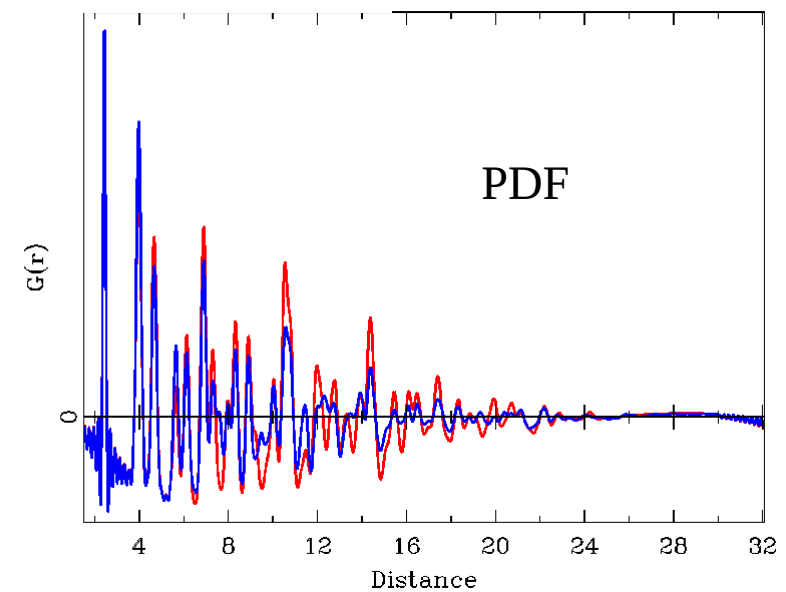
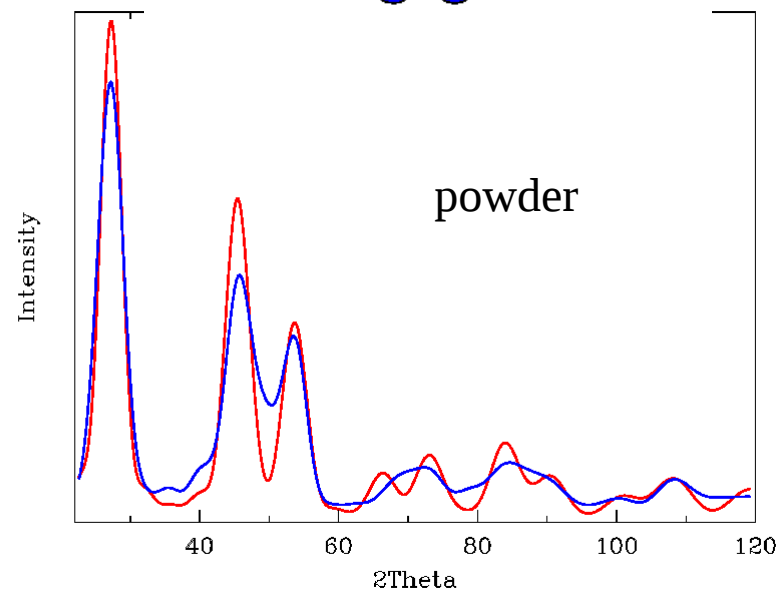
Aspects of PDF calculation for small nanoparticles



10 layers
simulated with
identical parameters

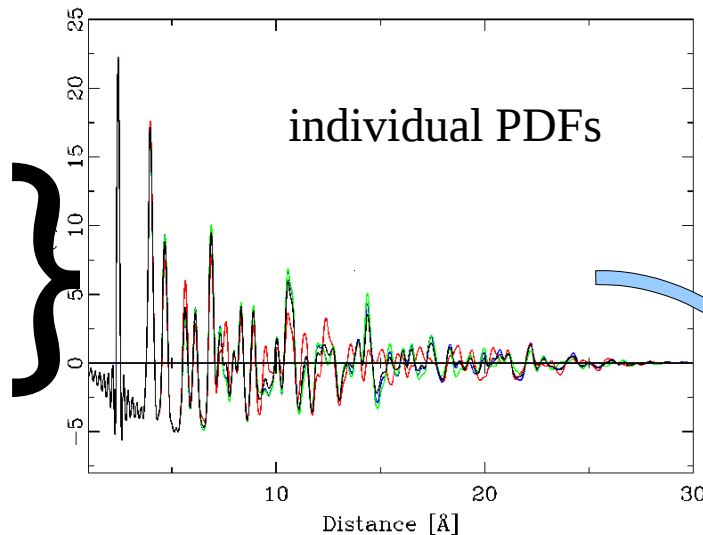
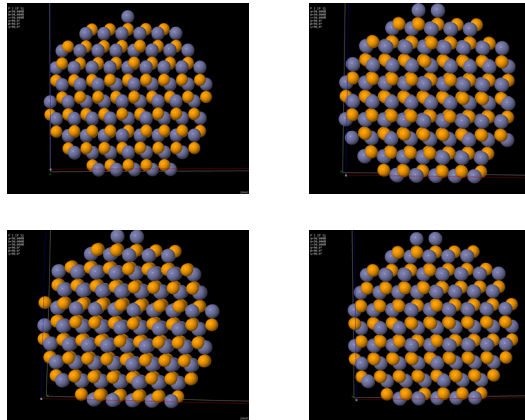
individual location
of stacking faults

each particle is not
representative
==> need to average



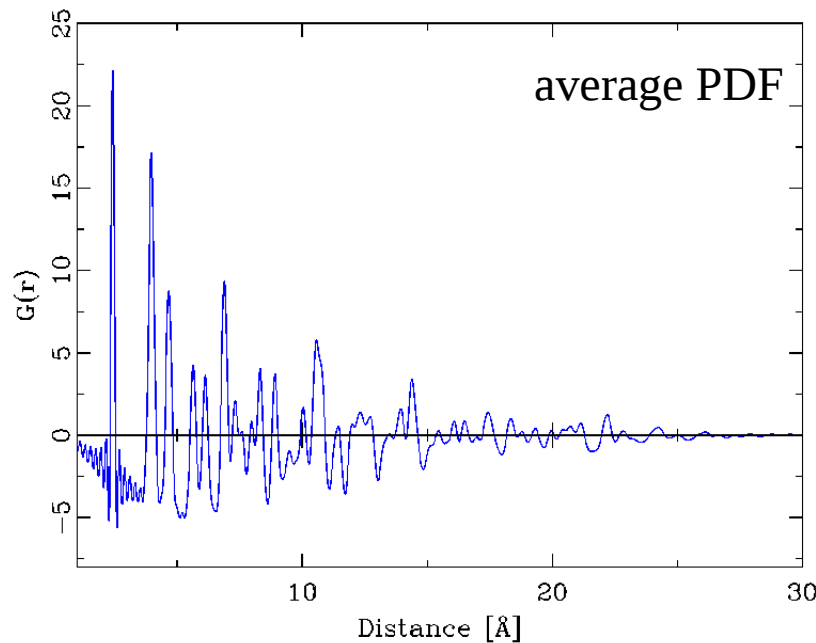
Bottom-Up Simulation and Refinement

Ensemble modelling



Calculate (many) individual nanos
Average PDF / powder pattern
coordinates in asymmetric unit
symmetry
diameter
defects

2 lattice parameters
1 coordinate
1 ADP
2 radii
1 probability

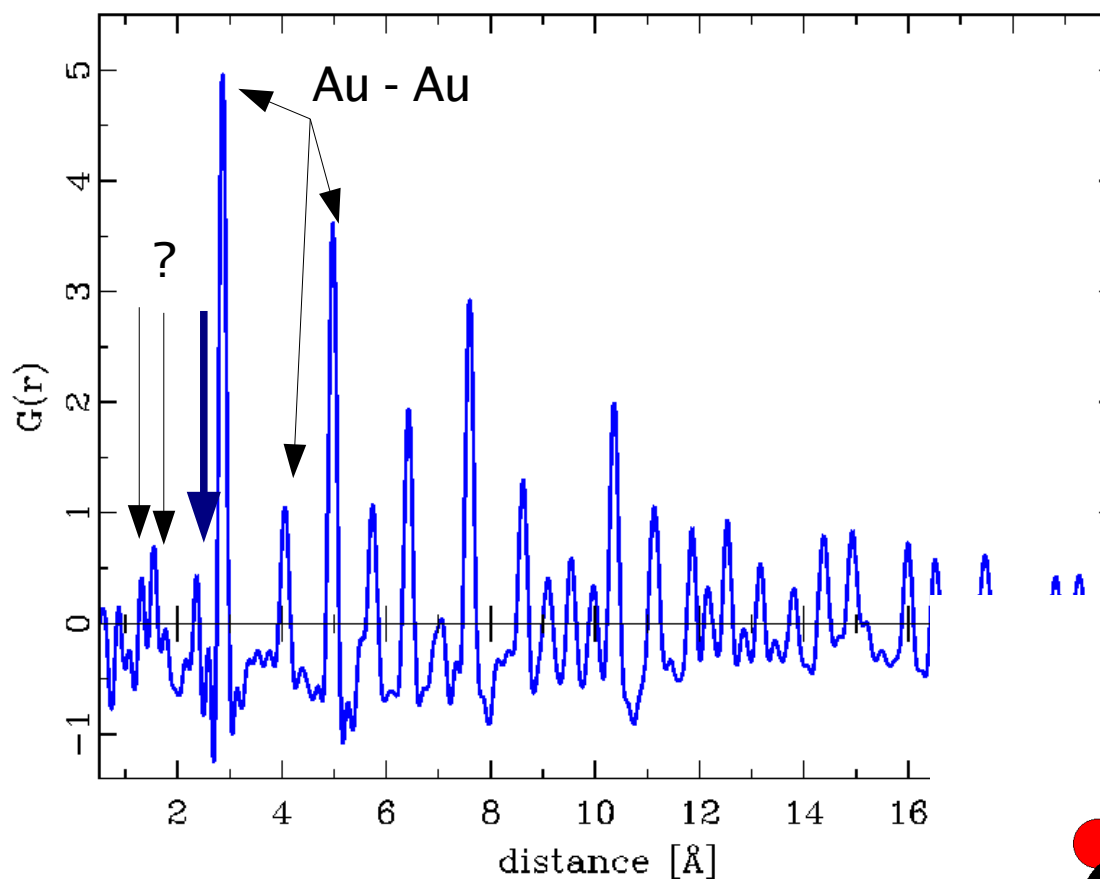


BUT

incoherent average of PDFs
requires evolutionary refinement
no Least-Squares
expensive

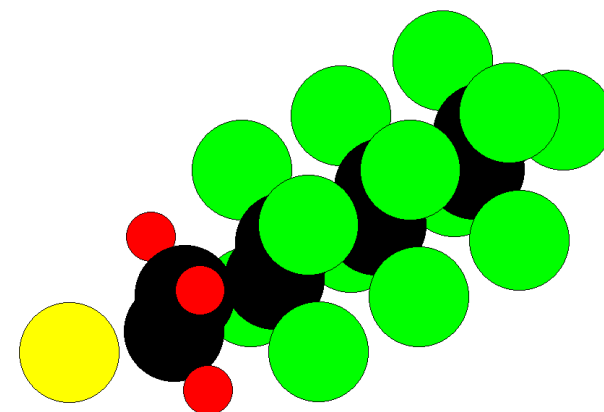
Gold -Ligand
Au - S 2.42Å

Ligand -
Ligand
C-C 1.5Å
C-F 1.3Å



Au
F m 3 m
a 4.064 Å
Au-Au 2.837Å

Number ?
Placement ?
Composition ?

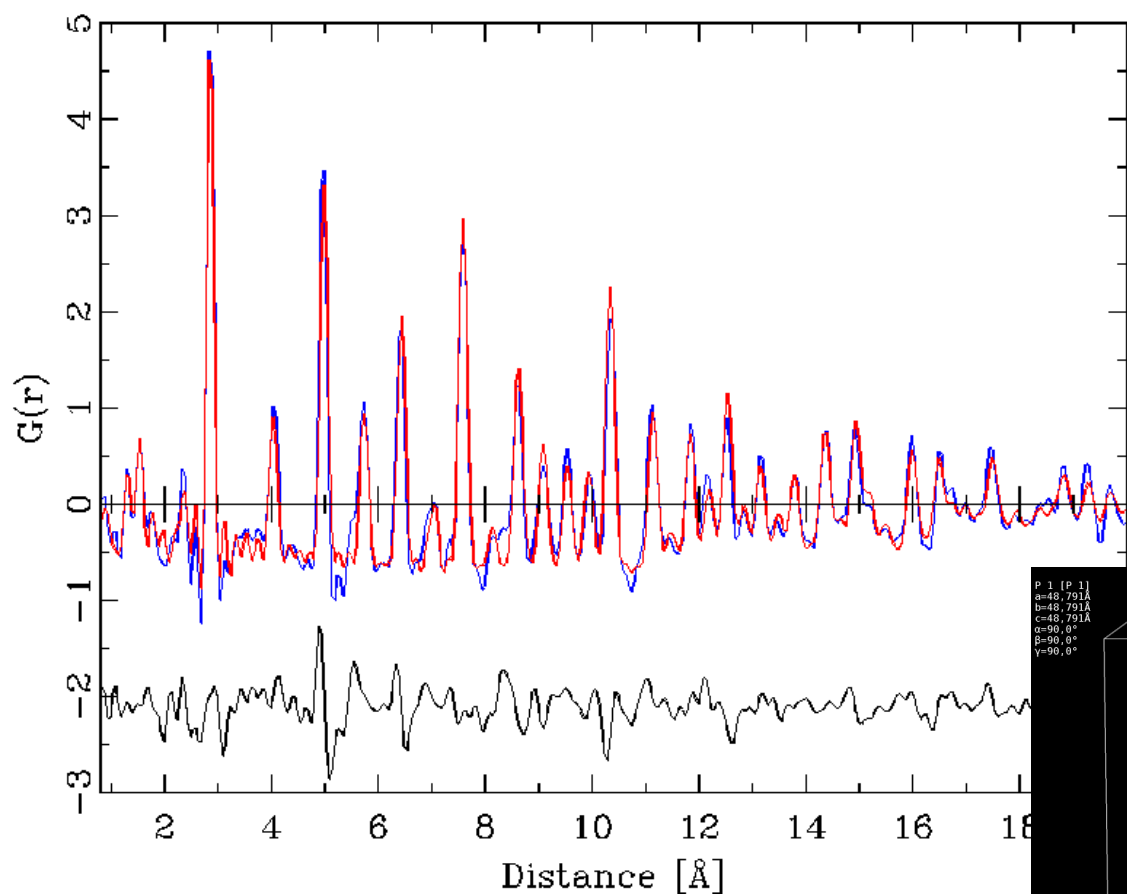


15 K
NPDF, Los Alamos
K. Page, Th. Proffen, T. Cheetham

Au + S-CH₂-CH₂-(CF₂)₅-CF₃
S C₈ H₄ F₁₃

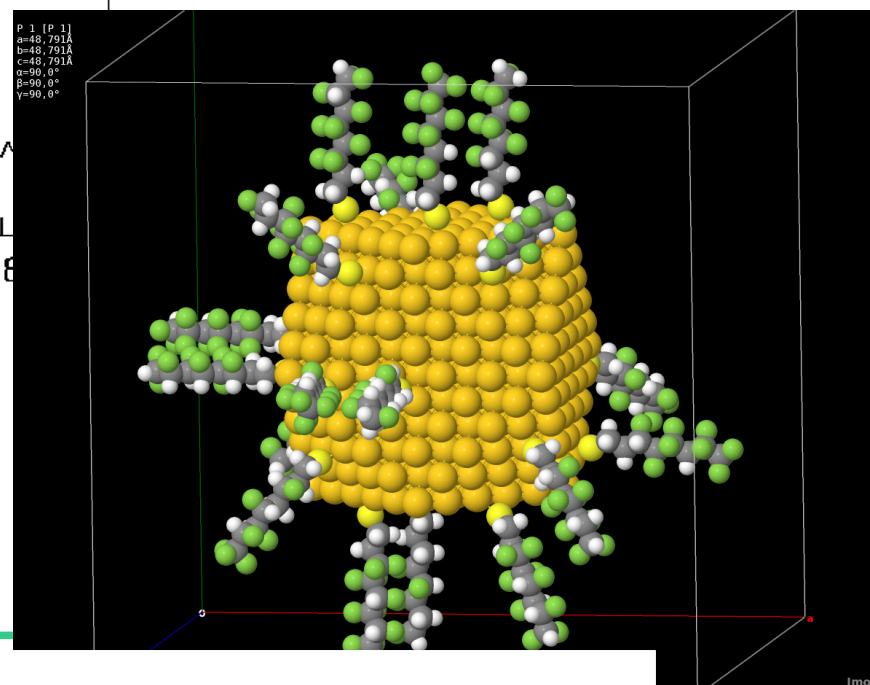
Ligand internal distances
from DFT calculations

Nanoparticle + Ligand



a(Au)	4.0658Å	(1)
Au – Au	2.8750Å	(1)
B(Au)	0.32Å ²	(4)
B(Ligand)	0.45Å ²	(10)
Diameter	20Å	(2)
N(ligand)	20	(6)
P(Fluorine)	0.65	(15)

Au – S 2.42Å fixed!



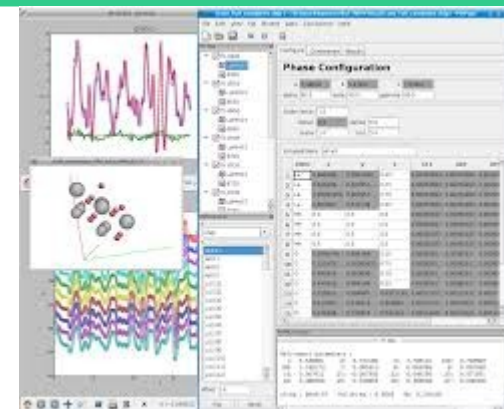
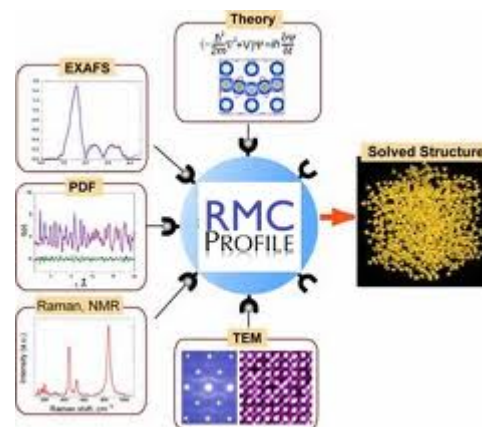
15 K
NPDF, Los Alamos

Small Box Modelling



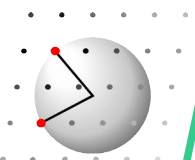
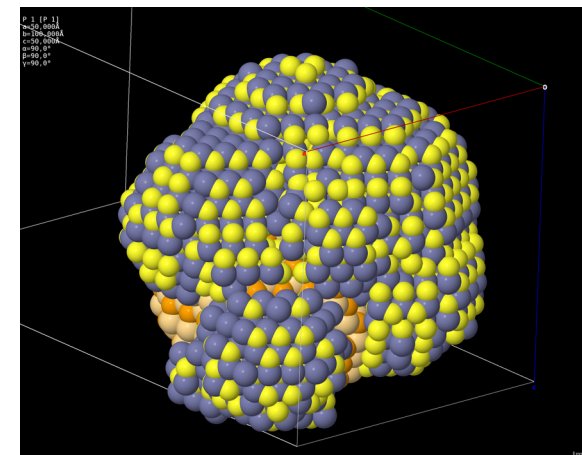
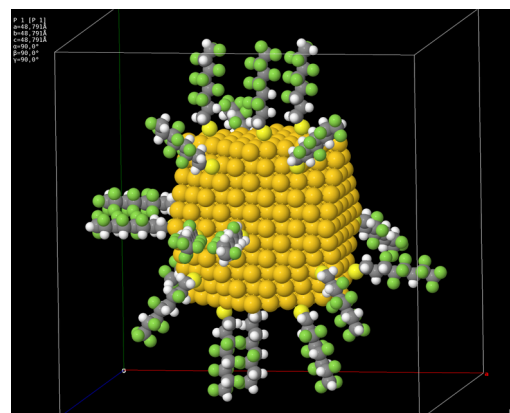
Large Box Modelling

Reverse Monte Carlo
RMCprofile
RMC_POT++
DISCUS



Bottom Up Modelling

DISCUS



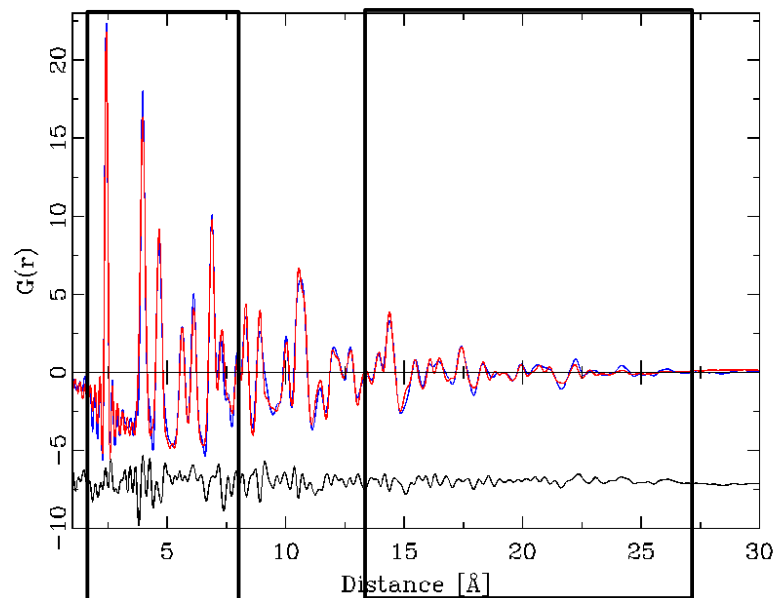
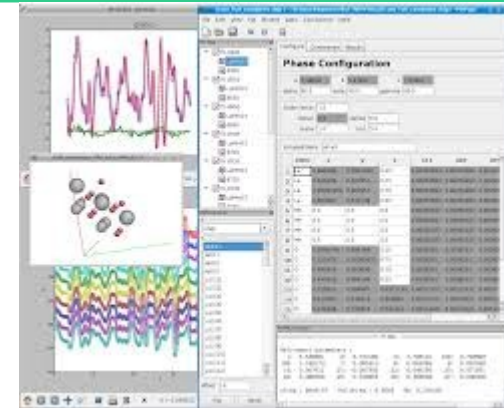
Small Box Modelling



Rietveld type refinement

Calculate PDF from single unit cell or **small** block of cells

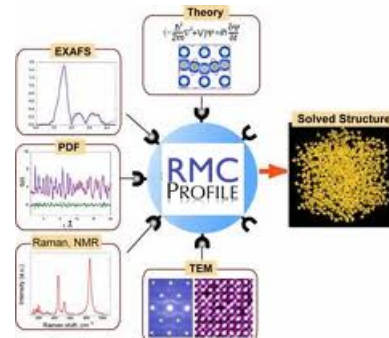
Determine changes in local versus moderate structure by
Separate refinement in restricted r-range



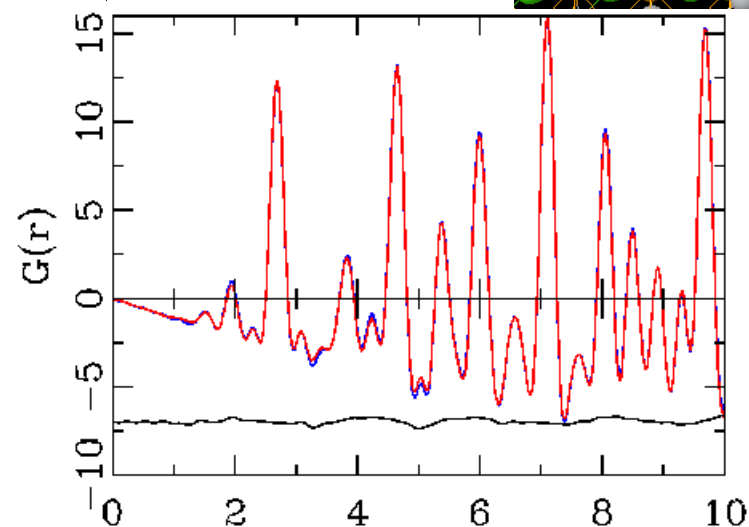
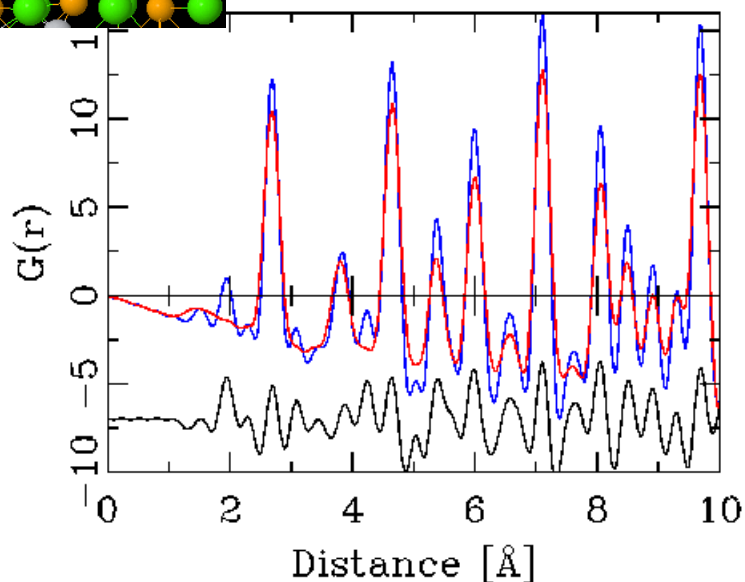
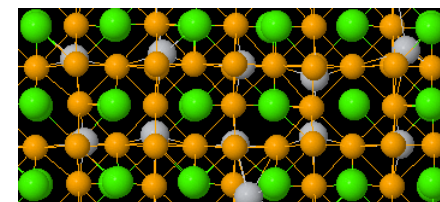
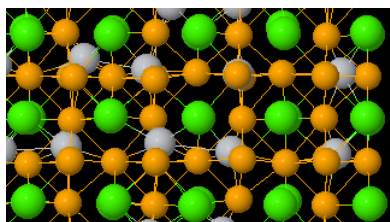
Large Box Modelling

Reverse Monte Carlo
RMCprofile
RMC_POT++

Model initial (random) **large** structure
Calculate PDF (+ powder + ...)



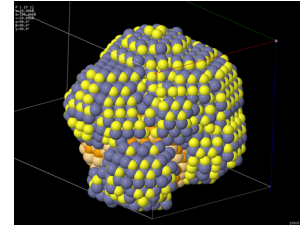
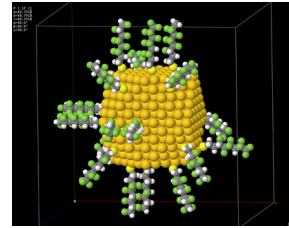
Modify structure (shift, exchange...)
while agreement improves
Usually requires constraints!



Analyze structure **afterwards**
Local coordination, shifts, etc.

Bottom Up Modelling

DISCUS



Define disorder rules to simulate complete structure

Non-periodic boundary conditions

Extended defect toolboxes

DISCUS program: discus.sourceforge.net; Neder & Proffen (Oxford)





Resources

Egami, T. & Billinge, S.J.L.	Underneath the Bragg Peaks, Elsevier
Dinnebier, R.E. & Billinge, S.J.L.	Powder Diffraction, RSC Publishing
Guagliardi, A. & Masciocchi, N.	Diffraction at the Nanoscale
Neder, R.B. in	Structure from Diffraction , Wiley
Nield, V. & Keen, D. A.	Diffuse Neutron Scattering from Crystalline Materials, Oxford
Welberry, R.	Diffuse X-ray Scattering and Models of Disorder, Oxford
Neder, R. & Proffen, T	Diffuse Scattering and Structure Simulation, Oxford
Beam lines Synchrotron 11-ID-B APS ID15-B, ESRF P02, DESY <i>P21, DESY</i> <i>Diamond</i>	Beam lines Neutron GEM, ISIS POLARIS, ISIS NOMAD, SNS; Oak Ridge

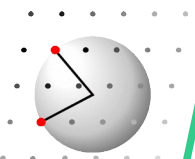
Thank you for your attention

PDFGui, SrFit: www.diffpy.org

RMCProfile: www.rmcprofile.org

RMC_POT: www.szfki.hu/~nphys/rmc++/opening.html

DISCUS: discus.sourceforge.net



R-dependent refinement

In-situ studies

Catalysts

Nanoparticle growth

Batteries

K. Chapman, P. Chupas

R.B. Neder B. Iversson

Element specific anomalous scattering V. Petkov

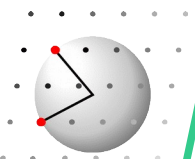
Several measurements close to an absorption edge

Neutron PDF

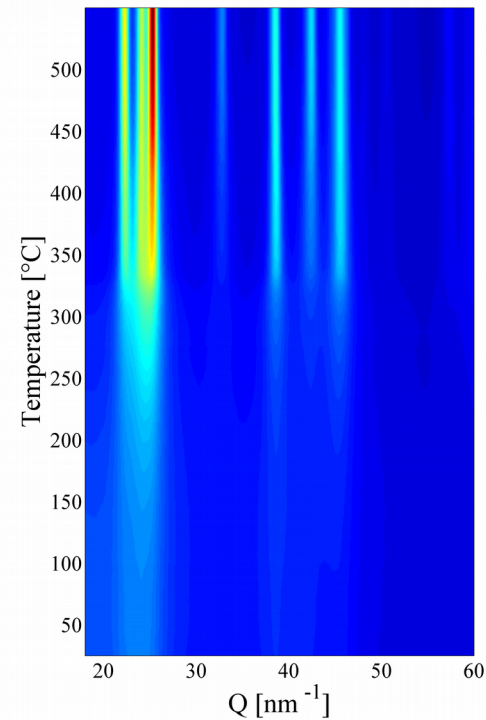
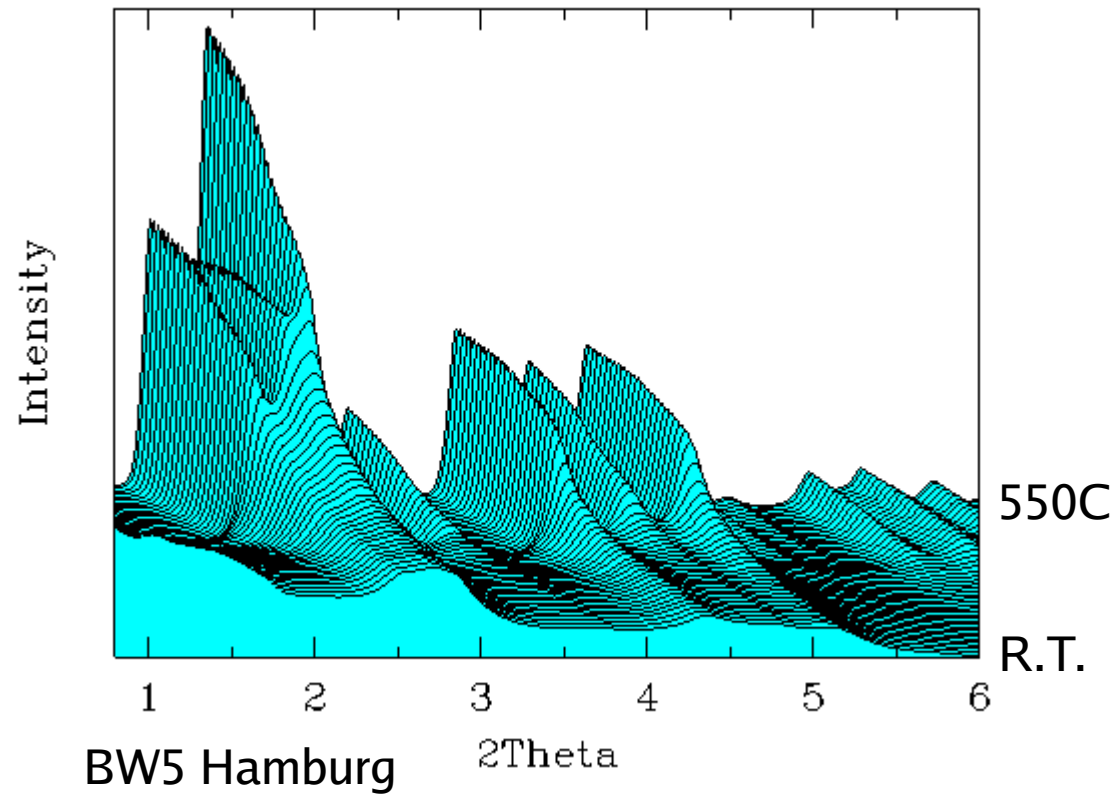
Electron PDF

Single crystal 3D PDF

Th. Weber, ETH Zürich



ZnO in-situ observation during heating run



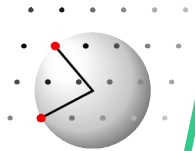
4K / min

1s/frame ==> 30 per image

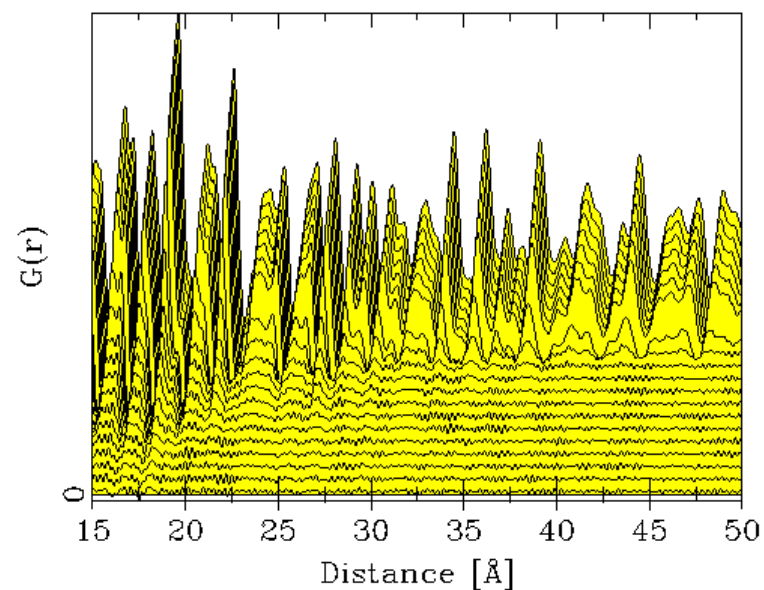
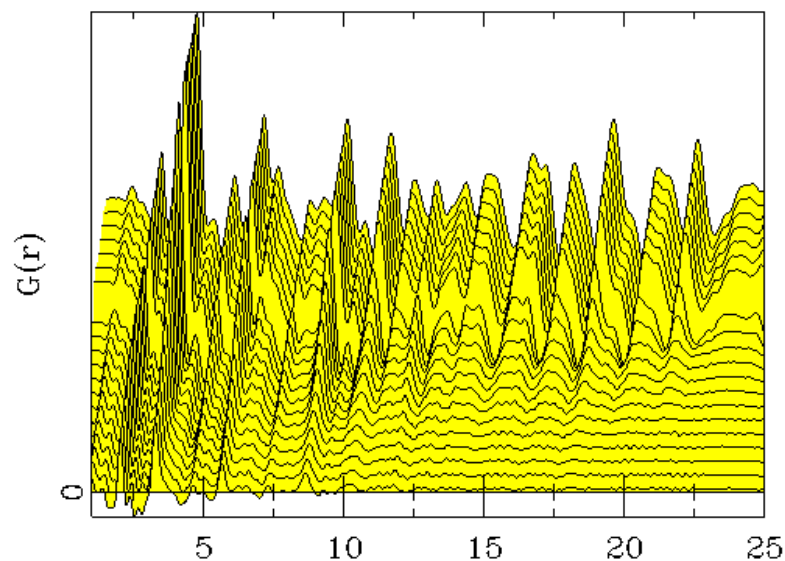
$\lambda = 0.123 \text{ \AA}$

Thermal annealing of ZnO nanoparticles
at T ==> 550°C

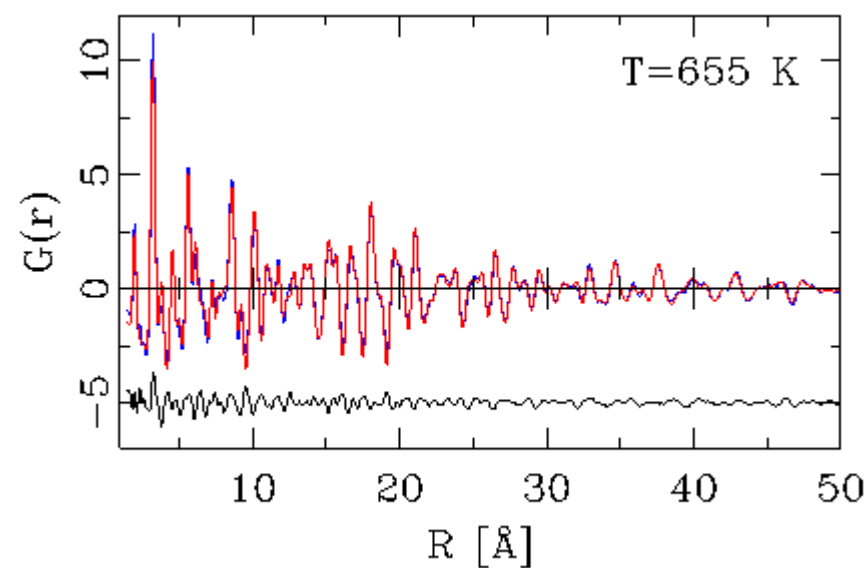
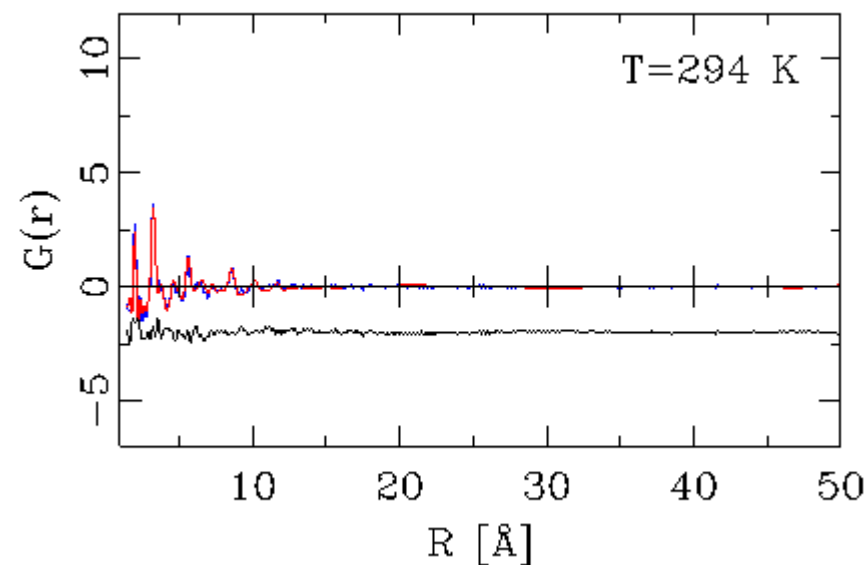
Solid state growth



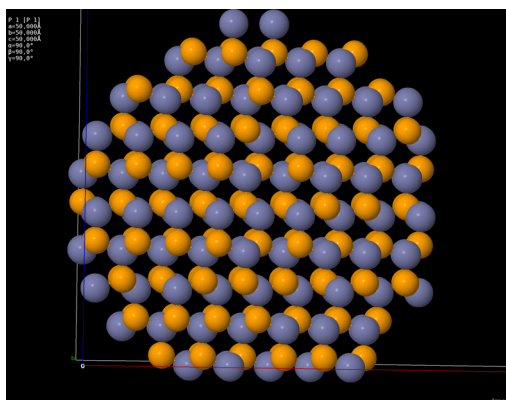
ZnO in-situ observation during heating run



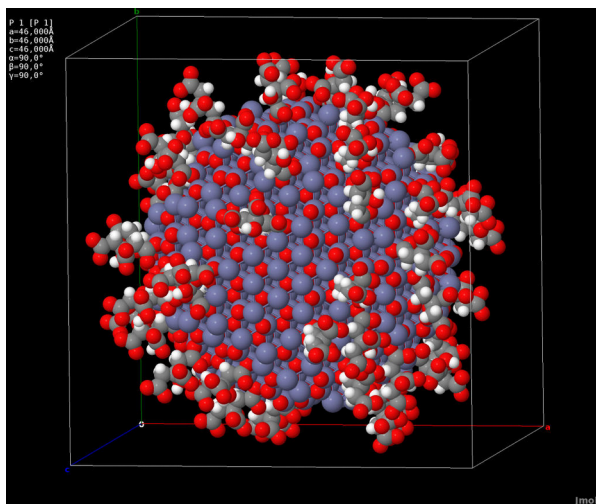
Explicit model
Triaxial ellipsoid
Wurtzite structure
Stacking faults



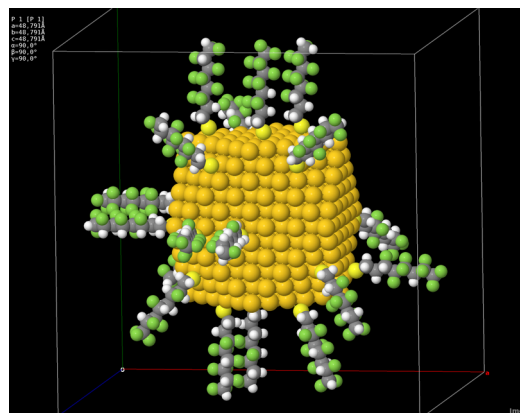
Pair Distribution Function



ZnSe Ellipsoid with
stacking faults

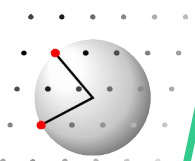
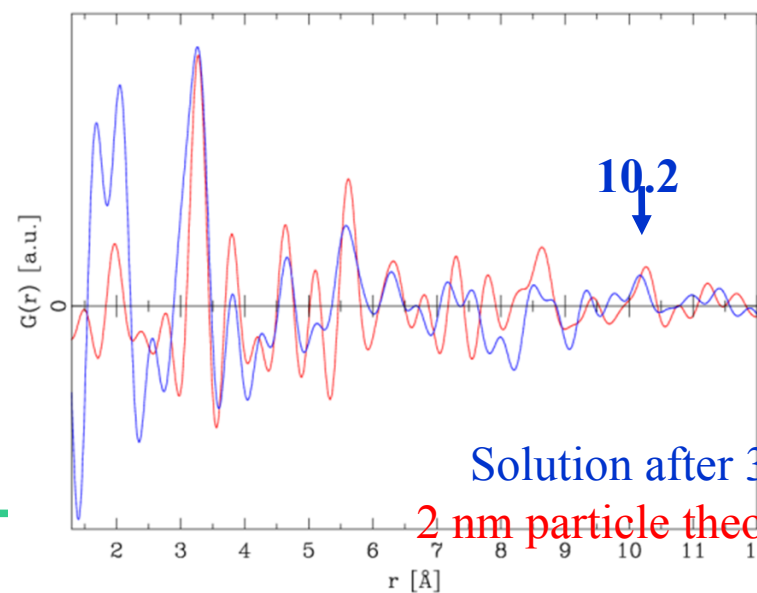
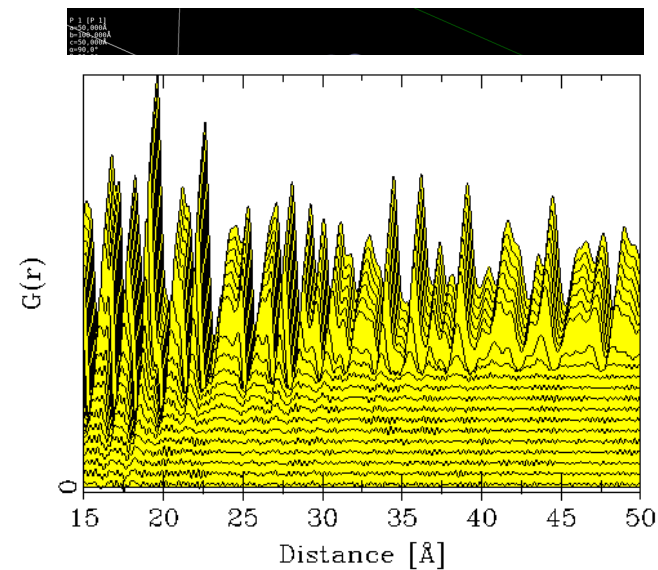


ZnO
with organic ligand



Gold cuboctahedron
with organic ligands

Very flexibel tool to analyze the local structure





Resources

Total Scattering School

August 6 – 10, 2019 Oak Ridge national laboratory USA

<https://conference.sns.gov/event/106/page/0>

Workshop Analysis of Diffraction in Real Space ADD2019

March 18 – 22, 2019 ILL, Grenoble France

<https://www.ill.eu/press-and-news/events/analysis-of-diffraction-data-in-real-space/>

DISCUS Workshop ECM 2019 Vienna, Austria

August 18 – 23, 2019 Vienna, Austria

<https://ecm2019.org/home/>

